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SIMS analysis of Si isotope for radiolarian test in Mesozoic bedded chert, Inuyama, central Japan

Maximilien BÔLE^{1, 2, 3*}, IKEDA Masayuki^{2, 3}, Peter O. BAUMGARTNER¹, HORI S. Rie⁴ and Anne-Sophie BOUVIER¹

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Abstract: The global silica cycle is an important component of the long-term climate system, yet its controlling factors are largely uncertain due to poorly constrained proxy records. Because radiolarians and other organisms preferentially extract lighter ²⁸Si from the ocean, the δ^{30} Si of biosiliceous tests can thus be used for a potential proxy of productivity. Additionally, δ^{30} Si of oceanic silica could have reflected changes in the isotopic ratio of sources and sinks.

Here we show δ^{30} Si records measured by secondary ion mass spectrometer (SIMS) in radiolarian silica, precipitated inside radiolarian molds in early Mesozoic bedded chert of the Inuyama section, central Japan. Range of measured δ^{30} Si between -0.3 and 2 ‰ is consistent with that of modern and Cenozoic radiolarian tests. Relatively large intra-chert bed variability up to ~ 0.8 ‰ (1SD) support that δ^{30} Si of the Mesozoic radiolarian molds are not perfectly homogenized in a chert bed during diagenesis. We found an overall inverse correlation between 10-Myr scale δ^{30} Si and biogenic silica (BSi) burial flux, which contradicts with a conventional interpretation of δ^{30} Si as paleoproductivity proxy, despite the low-resolution and scattered our δ^{30} Si records. Although most of the factors controlling oceanic δ^{30} Si are difficult to be constrained, this inverse relation might be explained by changes in δ^{30} Si of mafic/felsic rock weathering ratio, which inferred from paleogeography. Further high-resolution δ^{30} Si records will allow a better understanding of the past silica cycle.

Keywords: Silicon isotopes, δ^{30} Si, Radiolarites, Mesozoic oceanic silica cycle, SIMS

1. Introduction

The global silica cycle is linked to long-term changes in Earth's climate through feedback mechanisms between atmospheric CO₂, climate and the rate of silicate weathering, followed by carbonate and biogenic silica (BSi) deposition. Changes in Si and C cycle dynamics are linked to global climate changes throughout Earth's history, a relationship, which in turn, allows numerical models to reconstruct past atmospheric pCO₂ (Berner, 1991). Understanding the global silica cycle is therefore crucial to elucidate the response of Earth's surface system to changes in external (astronomical) and internal (tectonic and volcanic) forcings.

Silicate weathering and BSi burial are important to constrain the silica cycle as major source and sink,

respectively, but are difficult to quantify, and poorly understood their dynamic relation due to large uncertainties in the proxy records. Radiolarians dominated as producers of BSi during much of the Phanerozoic (Hein *et al.*, 1987), whereas siliceous sponges are largely restricted to marginal settings, and diatoms became quantitatively important only in the Cenozoic (Racki and Cordey, 2000; Kidder and Erwin, 2001). Radiolarites were deposited in a broad low-latitude belt, while radiolarian-bearing siliceous mudstones dominated in mid-latitudes (Baumgartner, 2013).

The volume of Paleozoic and Mesozoic Radiolarianrich deposits is largely underestimated, because much of the ocean floor has been subducted. Plate tectonic reconstructions of Panthalassa and Tethys, based on accreted remnants preserved in Circum-Caribbean,

¹ Institute of Earth Sciences (ISTE), Faculty of Geoscience, Geopolis, University of Lausanne, 1015 Lausanne, Switzerland

² Department of Geosciences, Faculty of Sciences, Shizuoka University, 836 Ohya Suruga, Shizuoka 422-8529, Japan.

³ Department of Earth and Planetary Science, Graduate School of Science, The University of Tokyo, 7-3-1 Hongo, Bunkyo-ku, Tokyo 113-0033 Japan

⁴Department of Earth Sciences, Faculty of Science, Ehime University, Bunkyo-cho 2-5, Matsuyama, Ehime 790-8577, Japan

^{*}Corresponding author: M, BÔLE., Rue des Envers 13, 2400 Le Locle, Switzerland

Circum-Pacific and Himalayan terranes, suggest that radiolarian-rich sediments covered more than 80 % of the area of the Mesozoic ocean (Baumgartner *et al.*, 2018).

The modern oceanic silica cycle is relatively wellknown, and is considered to be close to steady state (Tréguer and De La Rocha, 2013). Rivers are the main suppliers of silicic acid to oceans followed by seafloor weathering, groundwater, hydrothermal and aeolian inputs. The surface BSi production of diatoms overpasses by two orders of magnitude of the total silicon input to the ocean resulting in high dissolved silica (DSi) undersaturation and strong recycling. With depth, the undersaturation becomes weaker due to silicon recycling, but never reaches the saturation of any silica phases. Only about 3 % of BSi produced in the photic zone is trapped in sediments (Tréguer and De La Rocha, 2013). If steady state is assumed, the total BSi burial has to be proportional to the total input from all sources on timescales longer than the residence time of oceanic DSi (Treguer and De La Rocha, 2013).

BSi of radiolarian silica in bedded cherts is potentially a unique proxy for past Si cycle, because the estimated radiolarian BSi burial flux in the low-latitude pelagic Panthalassa was comparable with the modern global BSi flux, and was the possible major sink of DSi (Ikeda *et al.*, 2017). This hypothesis is consistent with overall in-phase relation between radiolarian BSi flux and global silicate weathering flux calculated by GEOCARBSULFvolc model (Ikeda *et al.*, 2017), implying that the estimated BSi burial flux can be proportional to silicate weathering flux over timescales longer than residence time of oceanic Si (<100 kyr; Ritterbush *et al.*, 2015).

However, controlling factors for the BSi burial are still controversial. Although changes in oceanic upwelling intensity and consequent BSi productivity are proposed as potential controlling factors (Hori et al., 1993; De Wever et al., 2014), their temporal variations are also difficult to be understood due to large uncertainty in their proxy records, such as Al/Ti ratio (Murray et al., 1993; Murray and Leinen, 1996; Dymond et al., 1997). On the other hand, controlling factors for siliceous weathering are also still debated. Today, more than 70 % of silicate weathering occurs only in <10 % land area with highly-weatherable volcanic rock region under humid monsoonal climate (Hartmann et al., 2014). Considering the Mesozoic paleogeography, wide distribution of the volcanic islands and large igneous provinces under intensified megamonsoonal climate could have further modulate the global silicate weathering (Ikeda et al., 2017), despite of lack of quantitative constraints.

Si isotope of BSi is a potential proxy to understand past Si cycle. Glacial-Interglacial scale δ^{30} Si variations have been documented (e.g. Brzezinski *et al.*, 2002), potentially due to an increase of the diatom productivity and extraction of light silicon by diatoms during interglacial periods (De La Rocha *et al.*, 1998).

Only few scattered data of δ^{30} Si from radiolaria are

published. (Wu *et al.*, 1997; Egan *et al.* 2012; Ding *et al.*, 1996; Hendry *et al.* 2014; Abelmann *et al.*, 2015; Fontorbe *et al.*, 2016). Silicon fractionation by modern radiolarians varies between -0.8 ‰ and -2.1 ‰ (Egan *et al.*, 2012; Abelmann *et al.*, 2015), which is similar to that by diatom (Frings *et al.*, 2016). Although factors controlling of δ^{30} Si records of radiolarian test are still debated, even for Cenozoic (e.g. Fontorbe *et al.*, 2016), early Mesozoic Si cycle seems to be a simpler system due to lack of diatom in continent and ocean. In this paper, we investigated the past oceanic silica cycle through in situ δ^{30} Si in radiolarian molds of Mesozoic bedded cherts. Then we compared our δ^{30} Si records with BSi burial flux (Ikeda *et al.*, 2017), to constrain the early Mesozoic Si cycle.

2. Material

We sampled material from bedded cherts from the Inuyama area, central Japan (Fig. 1). These cherts are part of an accretionary prism and are incorporated into several tectonic imbricates (Matsuda and Isozaki, 1991; Kimura and Hori, 1993). High-resolution radiolarian and conodont biostratigraphy, chemo-cyclostratigraphy in this succession have allowed to reconstruct the best studied Early Triassic to Early Jurassic bedded chert sequence (Yao et al., 1980, Hori, 1990; Sugiyama, 1997; Ikeda et al., 2010; Ikeda and Tada, 2013, 2014). Based on biostratigraphic age constraints, average duration of a chert-shale couplet are ~20 kyr throughout the early Mesozoic (Ikeda et al., 2010; Ikeda and Tada, 2014), which is consistent with the precession-scale changes in the accumulation rate of BSi under the extremely slow accumulation of shale mostly composed of aeolian dust (e.g. Hori et al., 1993). Estimated BSi fluctuations should be proportional to DSi input from chemical weathering paced with the monsoon dynamics, over timescales longer than the residence time of oceanic DSi (20 kyr; Tréguer and De La Rocha, 2013; <~100 kyr; Ritterbush et al., 2015), because low-mid-latitude BSi burial flux (Ikeda et al., 2017) is ~90 % of the modern global ocean (Tréguer and De La Rocha, 2013) and was a major sink for oceanic DSi.

Bedded cherts are rocks composed of chert layers (Si-rich), interbedded with clay-rich shale partings (Si-poor), produced by differential compaction and diagenetic reactions of dissolution-precipitation usually forming opal-CT and later quartz (Isaacs, 1981; Tada, 1991). Radiolarian molds filled with nearly pure microquartz and/or chalcedony are found in the silica-rich matrix of cherts. The radiolarian molds that we measured are commonly spherical. Therefore, they could result from Spumellaria, which have regularly a spherical morphology, dwelling in a photic zone due to their symbiotic relation with photosynthetic algae (e.g. Swanberg and Anderson, 1985; Takahashi *et al.*, 2003).

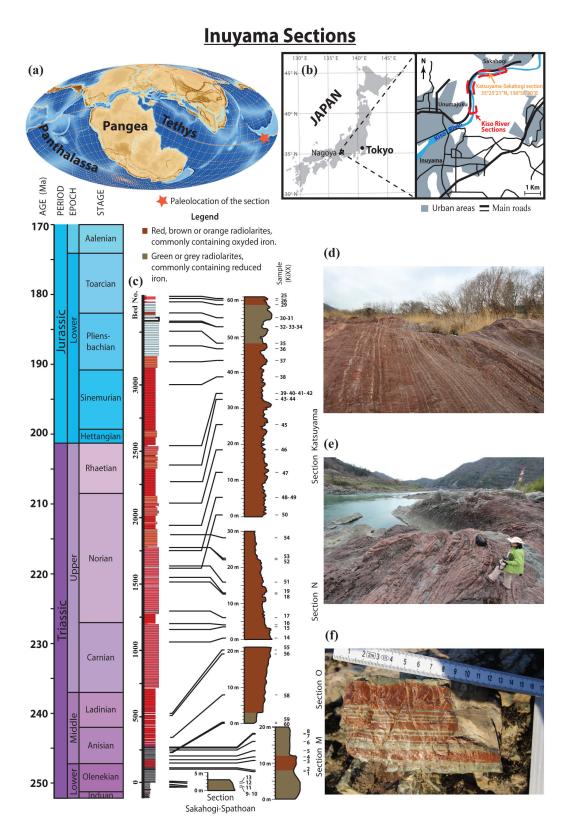


Fig. 1 Log of the Inuyama sections with their Triassic-Early Jurassic paleogeography on a map of Middle Jurassic (a) and their current location (b). The Paleomap (a) is from the Stampfli model developed at the University of Lausanne (Stampfli and Borel, 2002). The bed number log (c) is from Ikeda and Tada (2014). Additional information on the Kiso River sections can be found in Sugiyama (1997). These radiolarites are illustrated through (d) the nice parallel bedding for Late Triassic bedded chert (35°23'57" N, 136°57'34" E), (e) outcropping of Rhatian bedded chert along the Kiso River (35°25'21" N, 136°58'16" E) and (f) millimetric laminations inside single Norian bed (Ki18).

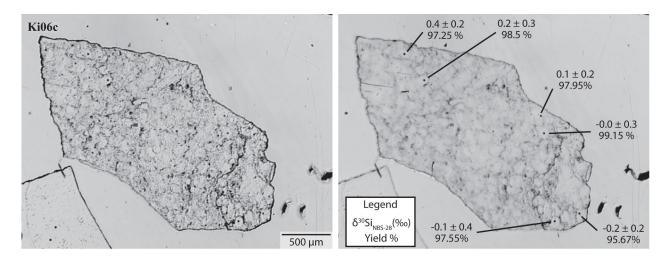


Fig. 2 δ³⁰Si_{NBS-28} measurements on sample Ki06c with analytical yield percent relative to the yield of the Paine Quartz Standard (UNIL Q1). Image on the right are out of focus to better distinguish the analytical spots.

3. Methods

In total, 34 cherts were analysed for the Inuyama section. Sample holders consists of ten fragments of different samples mounted into epoxide around an internal standard. These fragments were previously polished into trapezoidal shapes and the presence of radiolarian molds was checked by optical methods.

The δ^{30} Si of micro-crystalline quartz precipitated inside radiolarian molds was measured by SIMS at University of Lausanne with a primary Cs⁺ ion beam intensity of 2 nA, resulting in a $\sim 10 \, \mu m$ spot (cf. Seitz et al., 2017), to avoid contamination from other sources of silicon in radiolarites (detrital/aeolian minerals). Secondary ions ³⁰Si and ²⁸Si were analyzed at 3000 MRP and collected on Faraday cups (FC) multi-collection mode. The resistances of the L'2 and H'2 FC were $10^{11} \Omega$ for the detection of ²⁸Si and ³⁰Si, respectively. FCs were calibrated in the beginning of each session, using the calibration routine. Mass calibration was performed at the beginning of each session and every 12 h. Samples were gold coated to dissipated charges. Each analysis consists of 20 cycles of 5 sec, and starts with a presputtering time of 30 sec to remove gold and stabilize the secondary ion emission. The standard deviation of each analysis is expressed as analytical standard deviation. The data have been obtained in 7 different sessions for δ^{30} Si measurements, over 7 months.

For each chert sample, we made 4-10 measurements within about 0.5 cm stratigraphic interval (Fig. 2). A quartz internal standard (UNIL_Q1; Paine Quartz; Seitz *et al.*, 2017 for δ^{18} O and method; δ^{30} Si_{NBS-28} = -0.13 \pm 0.02 % (2SD)) was analysed every 6-10 measurements for instrumental drift correction and calibration.

We subsequently controlled by optical methods that the ion beam actually hit the radiolarian molds for each measurement. In addition, data were postprocessed using the analytical yield and the analytical deviation of each measurement. The analytical yield depends on the nature of the analysed material (mineral species and matrix effect) and on the topography of the analysed surface which modifies the incident angle of the primary ion beam. In addition to instrumental instabilities, the high analytical deviation can also indicate heterogeneity and the analyse of a mixture of silica, clays minerals and/or oxides. Regarding these considerations, the analytical yield and deviation are objective parameters to decide if a measurement must be rejected.

The drift correction was realized using a least square regression line weighted for incertitude (σ_{ϵ}^2) . For the calibration, we calculated the least square δ^{30} Si-mean (\dot{x}) and standard deviation ($\dot{\sigma}$) for the internal standard also weighted for incertitude (Equation 1 and 2) to keep consistent data processing with the least square drift correction. The calibrated δ^{30} Si for samples (δ^{30} Si_{NBS-28} *Spl*) depend on each sample measurement (δ^{30} *Si Spl*_{measured}) and are proportional to the measured least square δ^{30} Simean and the true δ^{30} Si_{NBS-28} from the internal standard (δ^{30} Si Std_{measured} and δ^{30} Si_{NBS-28} Std, respectively) (Equation 3). The errors on the calibrated δ^{30} Si $(\sigma(\delta^{30} Si_{NBS-28} Spl))$ were obtained by error propagation (Equation 4). The weighted means and standard deviations (Table 2 and Appendix Tables A1 and A2) were then calculated for each sample following equation 1 and 2. Raw, drift corrected and calibrated data are indicated in appendix tables. The δ^{30} Sidata were then filtered with a 10 Ma moving windows average with a step of 5 Ma and compared with estimation of the BSi burial rates in the Inuyama area (Ikeda et al., 2017).

Equation 1

$$\underline{\dot{x}} = \sum \left(\frac{1}{\sigma_i^2} \times x_i\right) / \left(\frac{1}{\sigma_i^2}\right)$$

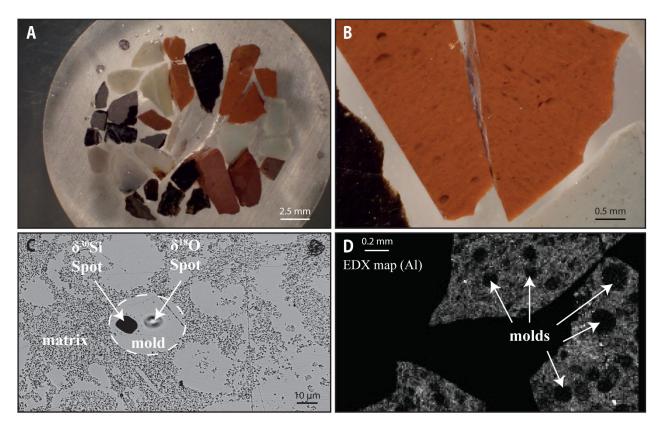


Fig. 3 Illustration of the analyzed materials. A) epoxy sample mount (Br7) including several fragments of about 10 samples. B) Zoom on a sample in this mount with binocular. C) Image of two spots left by a SIMS analysis (δ¹8O and δ³0Si) in radiolarian silica (radiolarian molds) on a gold coated sample mount. The δ¹8O-spot on the right is covered by a new gold coating. The difference of polishing between the radiolarian molds of nearly pure microcrystalline quartz and the matrix is well illustrated on this image.
D) SEM imaging of the aluminium distribution in the sample Ki08c (EDX map). Radiolarian molds are aluminium-free on this image.

Equation 2

$$\dot{\sigma_i} = \sqrt{\sum \left(\frac{1}{\sigma_i^2} \times (x_i - \underline{\dot{x}})^2\right) / \sum \left(\frac{1}{\sigma_i^2}\right) \times \frac{N}{N-1}}$$

Equation 3

$$\begin{split} \delta^{30} Si_{NBS-28} \, Spl \\ &= \left(\left(\left(1 \, + \, \frac{\delta^{30} Si \, Spl_{measured}}{1000} \right) \right. \right. \\ &\left. / \, \frac{(1 \, + \, \delta^{30} Si \, Std_{measured} \, / \, 1000)}{(1 \, + \, \delta^{30} Si_{NBS-28} \, Std \, / \, 1000)} \right) - 1 \right) \times 1000 \end{split}$$

Equation 4

$$\sigma(\delta^{30}Si_{NBS-28}Spl)$$

$$= \sqrt{(\frac{\partial F}{\partial V_1} \times dV_1)^2 + (\frac{\partial F}{\partial V_2} \times dV_2)^2 + (\frac{\partial F}{\partial V_3} \times dV_3)^2}$$
With $F = \delta^{30}Si_{NBS-28}Spl, V_1 = \delta^{30}Si Spl_{measured}, V_2 =$

 $\delta^{30} Si Std_{measured}$ and $V_3 = \delta^{30} Si_{NBS-28} Std$

For the SIMS analyses, it is common to use 2SD, which make sense considering the high accuracy of the method or when measuring very homogenous samples. 2SD was thus also used to discuss the UNIL-Q1 δ^{30} Si. We used 1SD for the LS-mean of samples and for their moving average, following usage in palaeoceanography, such as δ^{13} C and δ^{18} O in low magnesium calcium shells through time (e.g. Veizer *et al.*, 1999).

We also use scanning electron microscopy-energy dispersive X-ray spectrometry (SEM-EDS) in Lausanne University to map the elemental distribution in chert (Fig. 3).

4. Results

All the analytical dataset of our samples and a standard is presented in Appendix Tables, and is summarised in Tables 1 and 2. The means and standard deviations (2SD) of the raw δ^{30} Si from UNIL-Q1 range from -41.77 ‰ to -45.6 ‰ and from 0.33 ‰ to 0.69 ‰, respectively (Table 1). The drift correction only slightly reduced the standard deviations (0.29 ‰ to 0.68 ‰; 2SD). Calibrating data using the LS-means of standard, the arithmetic means and standard deviation (2SD) of the δ^{30} Si_{NBS-28} values

Raw, drift corrected and calibrated δ^{39} Si means and standard deviations (2 SD) for the UNIL-Q1 standard (in ‰) between our different sessions. Instrumental fractionation is calculated based on the least square mean and standard deviation of the drift corrected 830Si The 830Si NBS 28 mean and standard deviation (2 SD) of calibrated data are given for all standard measured through a session and for the average $\delta^{30}S_{INBS-28}$ of the different standard clusters. Reproducibility of the $\delta^{30}S_{INBS-28}$ based on the average $\delta^{30}S_{INBS-28}$ of the different standard clusters is much better than on all standard measured (< 0.37 ‰, 2SD vs < 0.71 ‰)

		Raw δ^{30} Si (%o)	Si (%)		drift correc	drift corrected δ^{30} Si (‰)	(0			Calibrated $\delta^{30} \mathrm{Si_{NBS-28}}$ (%)	Si _{NBS-28} (%0)		Reproducibility	Reproducibility of $\delta^{30} \mathrm{Si}_{\mathrm{NBS-28}}$ (%)
Session	Number of bracketing	All standard	ndard		All s	standard		Fractionation based on	All standard	ndard	Standard clusters	clusters	All standard	Standard clusters
	standard	mean	2 SD	mean	2 SD	LS-mean	LS-STD (1SD)		mean	2SD	mean	2SD	2SD	2SD
Br2	36	42.67	0.38	-42.67	0.38	-42.65	0.19	1.0444	-0.15	0.40	-0.15	0.21	0.40	0.21
Br3	28	42.84	0.33	-42.84	0.31	-42.84	0.16	1.0446	-0.13	0.33	-0.13	0.15	0.33	0.15
Br4	16	45.60	0.49	-45.60	0.39	-45.61	0.19	1.0477	-0.12	0.40	-0.12	0.36	0.40	0.36
Br4v2	18	43.08	69.0	-43.08	89.0	-43.12	0.37	1.0449	60.0-	0.71	-0.09	0.02	0.71	0.03
Br6	40	45.36	0.67	-45.38	99.0	-45.36	0.31	1.0474	-0.15	69.0	-0.15	0.20	69.0	0.21
Br7	40	42.44	0.35	-42.44	0.33	-42.44	0.17	1.0442	-0.13	0.35	-0.13	0.25	0.35	0.25
Brl	24	41.77	0.37	-41.77	0.29	-41.76	0.12	1.0434	-0.14	0.30	-0.14	0.13	0.30	0.13
Br5	44	41.79	0.39	-41.79	0.39	-41.80	0.19	1.0435	-0.12	0.41	-0.12	0.17	0.41	0.17
mean		43.19		-43.20		-43.20			-0.13		-0.13			
2SD		2.97		2.98		2.98			0.04		0.04			

from our standards vary from -0.09 % to -0.15 % and from 0.30 % to 0.71 %, respectively. The average of the arithmetic $\delta^{30} \rm Si_{NBS-28}$ means obtained during different sessions is thus -0.13 \pm 0.04 % (2SD) which is relatively similar to the bulk UNIL-Q1 $\delta^{30} \rm Si_{NBS-28}$ (-0.13 \pm 0.02 %; 2SD) and bellow the reproducibility of all $\delta^{30} \rm Si_{NBS-28}$ from standard during a single session. We removed 6 on 189 measurements of samples which had yield deviating more than 10 % from the yield of the quartz standard or their analytical deviation (2SD) exceeding 0.37 %.

LS-mean δ^{30} Si of measured radiolarian molds ranges from -0.3 % to 2 % (Table 2). δ^{30} Si-means have an intersample range of up to 2.3 %, which is higher than their standard deviation (Table 2). The intra-sample standard deviations (1SD) of the δ^{30} Si-means varies between 0.1 % and 0.75 %. The δ^{30} Si-means from our samples range from -0.3 % to 0.8 % during the Early Triassic, from -0.3 % to 1 % during the Middle Triassic, from -0.3 % to 1.5 % during the Late Triassic, and from 0.5 % to 2 % during the Early Jurassic (Fig. 4). The low δ^{30} Si-values from 10-Myr moving windows average are overall associated with high BSi burial rates (Ikeda *et al.*, 2017). A mapping of the aluminium content by SEM-EDS shows that clay minerals are concentrated in the matrix (Fig. 3).

5. Discussion

5. 1 δ^{30} Si of radiolarian molds and diagenesis

SIMS-measured δ^{30} Si for Mesozoic radiolarian molds ranges from -0.3 ‰ to 2 ‰ (Fig. 4), which overlap with the range of Cenozoic radiolarian tests (e.g. Fontorbe *et al.*, 2016; Fig. 5), potentially supporting that the Mesozoic radiolarian molds preserve the original values to some extent.

Radiolarian skeletons are originally composed of biogenic opal (opal-A), which is the most soluble silica phase (Walther and Helgeson 1977; Fournier and Rowe, 1977; Gunnarsson and Arnórsson, 2000). During the phase transitions from opal-A to opal-CT and quartz, silicon isotope of radiolarian molds might have changed by contamination of pore water DSi. However, migration of Si from the layers with low Si content (shale bed) to layers with high Si content (chert bed) allows us to ignore interbed migration of Si (Tada, 1991). The lower solubility of quartz (<1000 ppm) than opal-A (<2000 ppm) and opal-CT (<1500 ppm) (e.g. Gunnarsson and Arnórsson, 2000) further implicates the negligible effect of aeolian/detrital quartz dissolution on DSi of pore water. Additionally, clay mineral diagenesis occurs at higher temperature (80 °C; Chamley, 1989; Fagel 2007) than opal-CT transition (65 °C; Matheney and Knauth, 1993), which segregated biosiliceous sediments (Tada, 1991). Considering mass balance in the chert-dominant bedded chert succession with minor-clay component in the Inuyama area (Sugiyama, 1997), we can thus assume that the bulk δ^{30} Si of radiolarian molds in cherts would be equal to that of former opal-A.

Table 2 List of samples with their age, their δ^{30} Si_{NBS-28} Least square mean (LS-mean) and their δ^{30} Si least square standard deviation (LS-std; 1SD). The δ^{30} Si_{NBS-28} was averaged with a 10 Ma windows moving average (5 Ma step) and compared with BSi.

		. 81	R	esults	Curve	S
Sample	Age (Ma)	Number of measurements	δ^{30} Si	NBS-28 (‰)	$\delta^{30} {\rm Si}_{\rm NBS-28} \ (\%)$	Biosilica burial rate (g cm ⁻² Kyr ⁻¹)
	(Ivia)	Nuı	Th	is study	This study	Ikeda et al., 2017
		n	LS-mean	LS-std (1SD)	10 Ma moving average	10 Ma smooth
Ki20	174.00	5	2.0	0.7	1.42	
Ki22c1	178.00	8	1.1	0.1	1.24	
Ki22c2	178.00	3	0.8	0.2	1.24	
Ki21	178.00	9	1.2	0.3	1.24	
Ki27	180.99	6	0.5	0.6	1.26	0.26
Ki24	182.00	6	1.9	0.2	1.31	0.26
Ki32	184.20	10	2.0	0.4	1.43	0.26
Ki34	184.37	10	1.0	0.3	1.43	0.26
Ki35	185.62	9	2.0	0.2	1.45	0.25
Ki38	193.31	10	0.8	0.4	0.96	0.19
Ki40	201.50	5	0.8	0.5	1.22	0.23
Ki39	201.50	5	1.4	0.3	1.22	0.23
Ki41	201.50	1	1.1		1.22	0.23
Ki42	201.50	10	1.4	0.3	1.22	0.23
Ki44	204.82	9	1.4	0.1	1.22	0.25
ki43	204.82	6	1.2	0.3	1.22	0.25
Ki46	210.27	10	-0.3	0.6	-0.09	0.27
Ki54	214.40	6	0.0	0.5	0.40	0.26
ki48	217.09	4	1.0	0.4	0.71	0.25
Ki51	219.00	6	1.1	0.3	0.94	0.25
Ki15	228.00	10	1.1	0.3	1.10	0.21
Ki57	241.00	9	1.0	0.4	0.52	0.36
Ki58	243.48	6	0.6	0.5	0.39	0.36
Ki08	244.90	10	-0.2	0.3	0.32	0.35
Ki07	245.00	6	0.9	0.2	0.32	0.35
Ki06	245.25	6	0.0	0.3	0.31	0.35
Ki06s	245.25	14	-0.1	0.4	0.31	0.35
Ki05	246.20	6	-0.3	0.2	0.30	0.33
Ki04	246.60	9	0.7	0.3	0.30	0.33
Ki03	247.20	10	0.2	0.6	0.29	0.32
Ki02	247.80	7	0.4	0.4	0.28	0.31
Ki01	248.00	10	0.3	0.5	0.28	0.31
Ki10	250.20	6	-0.2	0.3	0.25	
Ki09	250.30	9	0.7	0.3	0.25	
	_0 0.50		V.1	Ü.5	Ü.25	

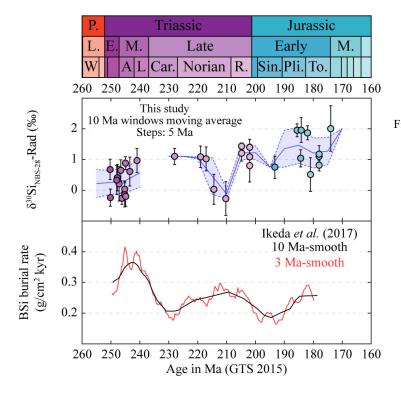


Fig. 4 Evolution of δ^{30} Si_{NBS-28} through time from radiolarian silica in the Inuyama Area (this study). Our results are compared with estimations of the BSi burial rate (Ikeda et al., 2017). The trend and variation of δ^{30} Si can be correlated (R= -0.73) with the trend and/or variations observed in the BSi burial rate. The geological timescale (GTS 2015) used for this figure is the timescale of the international commission of stratigraphy (Cohen et al. 2013). The color filling inside markers corresponds to the color of the geological stage. The boundaries of curves, when plotted, are equivalent to 1SD. The moving average for radiolarian silica is realized using a 10 Ma windows and 5 Ma steps. The δ^{30} Si_{NBS-28} error bars correspond to the least square standard deviation of samples presented in Table 2.

The relatively large internal δ^{30} Si-scattering up to 0.8 ‰ (1SD) for each sample suggests that kyr-scale δ^{30} Si heterogeneity within each chert sample still exist after the diagenesis. Micrometric isotopic variations have been previously observed even in Precambrian cherts, supporting that the δ^{30} Si is not homogenised through time in cherts (Marin-Carbonne *et al.*, 2011, 2012). Even fragments of cherts included as enclave in tonalitic intrusions (>700 °C) or metamorphosed in amphibolite facies seem to preserve their δ^{30} Si (André *et al.*, 2006). Therefore, it is reasonable to assess δ^{30} Si records of radiolarian molds in Mesozoic bedded chert as those in Mesozoic radiolarian tests, despite of diagenetic homogenization to some extent.

5. 2 Evolution of radiolarian δ^{30} Si

The increasing trend of radiolarian δ^{30} Si through the Triassic might be interpreted as an increase of the radiolarian productivity resulting in a higher biogenic fractionation (e.g. De La Rocha et al. 1998), despite of large scattering and complex fractionation of δ^{30} Si (Fig. 4). However, this conventional interpretation contradicts with low δ^{30} Si mainly associated with higher BSi burial rates (Ikeda et al., 2017) (Fig. 5). Upwelling of isotopically-light DSi might have affected the observed negative correlation between δ^{30} Si and BSi flux in equatorial Panthalassa. Regarding the radiolarian BSi as major sink of DSi in the Mesozoic ocean before the post-Cretaceous rise of diatoms (Ikeda *et al.*, 2017), however, radiolarian δ^{30} Si could have reflected $\delta^{30}Si$ of oceanic DSi on timescale longer than residence time of oceanic DSi (~100 kyr: Ritterbush et al., 2015).

 δ^{30} Si of oceanic DSi is controlled by changes in δ^{30} Si

values of sources and sinks (e.g. Frings *et al.*, 2016). Major source of oceanic DSi is river input, which δ^{30} Si currently varies from 0 % to 4 %, mainly depending on diatom uptake and rock types of provenance (e.g. Frings *et al.*, 2016). However, before the rise of diatom, biogenic uptake in continent can be negligible. Small difference exists between continental felsic rocks (δ^{30} Si = -0.5 to 0.5 %) and mantle-origin mafic rocks (δ^{30} Si = -1 to 0 %) (Opfergelt and Delmelle, 2012). Up to 1 % amplitudes of 10-Myr scale δ^{30} Si data can be explained by changes in felsic/mafic ratios, although our δ^{30} Si data is too low-resolution to discuss its <10-Myr scale dynamics.

On another hand, δ^{30} Si of siliceous sponges varies from -6 ‰ to -1 ‰ (Frings *et al.*, 2016), whereas that of radiolarias and diatoms varies from -1.1 ‰ to 1.7‰ (Abelmann *et al.*, 2015; Fontorbe *et al.*, 2016) and from -1 ‰ to 3 ‰ (e.g. Frings *et al.*, 2016), respectively. Changes in the relative contribution of sponge BSi deposition might be a candidate to explain δ^{30} Si variations, despite of lack of evidence of massive sponge deposition, except for some biotic events after Carnian Pluvial Event, Norian Manicouagan impact, and the end-Triassic extinction (Thibodeau *et al.*, 2016; Onoue *et al.*, 2016; Shi *et al.*, 2017). However, there are no significant δ^{30} Si variations across the end-Triassic extinction, implying negligible effect of sponge deposition on Si cycle at this event (Fig. 4).

On the other hand, 10-Myr scale BSi burial flux also correlates with calculated global silicate weathering rate, which potentially linked with changes in weathering of highly-weatherable volcanic rocks with lighter silicon isotope (Ikeda *et al.*, 2017). This idea is consistent with

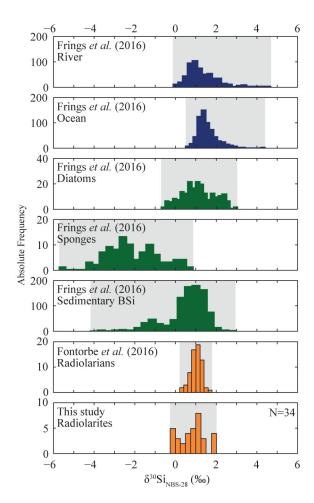


Fig. 5 $\delta^{30}\mathrm{Si_{NBS-28}}$ -distribution in rivers, oceans, diatoms, sponges and sedimentary biogenic silica from Frings *et al.* (2016) compared with $\delta^{30}\mathrm{Si_{NBS-28}}$ -distribution for Cenozoic radiolarians (Fontorbe *et al.*, 2016) and for the Triassic to Jurassic radiolarites from the Inuyama Area (this study). The relative similar range between Cenozoic radiolarians and Mesozoic radiolarites supports that the Mesozoic radiolarian molds preserve the original values.

the overall negative correlation between radiolarian $\delta^{30}Si$ and the BSi burial flux in the Inuyama area, despite of large scattering and low-resolution $\delta^{30}Si$ records (Fig. 4). Further high-resolution works are necessary to improve our understanding of $\delta^{30}Si$ cycle of radiolarian molds and unravelling some radiolarian crisis through geologic events, in response to bolide impact, massive volcanism, oceanic acidification, and oceanic anoxic events.

6. Conclusion and perspective

We measured $\delta^{30}Si$ of the Mesozoic radiolarian molds in Inuyama chert by SIMS. Range of $\delta^{30}Si$ between -0.3 and 2 ‰ is consistent with that of modern and Cenozoic radiolarian tests. Relatively large $\delta^{30}Si$ up to 0.8 ‰ (1SD) in intra-chert bed supports that $\delta^{30}Si$ of the Mesozoic radiolarian molds is not perfectly homogenized in a chert

bed during the diagenesis, and potentially record of kyrscale changes in radiolarian $\delta^{30}Si$. 10-Myr scale trend of $\delta^{30}Si$ of the Mesozoic radiolarian molds from 250 Ma to 180 Ma is overall out-of-phase relation with BSi burial flux. This relation contradicts with interpretation of $\delta^{30}Si$ as a productivity proxy, despite of low-resolution and scattered $\delta^{30}Si$ records. Further high-resolution analysis will allow a better understanding of the past silica cycle, opening the possibility of accurate estimations of the past oceanic silica cycle and the contribution of past radiolarian productivity.

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Appendix

Table A1 Least square drift corrected and calibrated δ^{30} Si measurements (‰) for each sample. The LS-mean and standard deviation for each sample is indicated in bold font. All δ^{30} Si are relative to NBS-28 and all standard deviations are given as 2σ . Analytical standard deviation is sometime higher than 0.37 (2SD) due the use of error propagation during calibration.

Sampl	le	Ki20	Ki22c2	Ki22c1	Ki21	Ki27	Ki24	Ki32	Ki34	Ki35	Ki38	Ki41	Ki39
age		174.00	178.00	178.00	178.00	180.99	182.00	184.20	184.37	185.62	193.31	201.50	201.50
LS-mean (δ ³⁶ and LS-SD (2		2.01 ± 1.47	0.82 ± 0.37	1.10 ± 0.29	1.18 ± 0.54	0.51 ± 1.10	1.87 ± 0.47	1.96 ± 0.79	1.04 ± 0.56	1.95 ± 0.42	0.75 ± 0.72	1.09 ± 0.20	1.40 ± 0.53
Number of mea	asurements	5	6	9	9	6	6	10	10	9	10	2	5
Accepted meas	surements	5	5	8	9	6	6	10	10	9	10	1	4
Rejected meas	surements	0	1	1	0	0	0	0	0	0	0	1	1
=	1	3.00 ± 0.31	0.79 ± 0.28	0.92 ± 0.28	1.17 ± 0.29	0.37 ± 0.25	2.02 ± 0.26	1.37 ± 0.20	0.58 ± 0.29	1.96 ± 0.26	1.39 ± 0.19	1.09 ± 0.20	1.68 ± 0.27
atio	2	2.13 ± 0.26	0.66 ± 0.27	0.93 ± 0.39	1.08 ± 0.21	1.16 ± 0.24	1.75 ± 0.20	1.92 ± 0.28	1.25 ± 0.21	2.22 ± 0.23	0.73 ± 0.33		1.31 ± 0.22
standard deviation urements (%)	3	2.52 ± 0.27	1.03 ± 0.33	1.08 ± 0.21	0.67 ± 0.28	0.96 ± 0.21	1.87 ± 0.27	1.74 ± 0.16	1.30 ± 0.25	2.06 ± 0.30	0.84 ± 0.34		1.62 ± 0.15
d d	4	1.16 ± 0.17		1.11 ± 0.28	1.52 ± 0.29	0.19 ± 0.19	2.16 ± 0.21	2.02 ± 0.24	0.85 ± 0.28	1.53 ± 0.19	1.14 ± 0.30		1.03 ± 0.17
ner	5	1.56 ± 0.19		1.18 ± 0.34	1.15 ± 0.24	-0.39 ± 0.33	1.92 ± 0.18	1.82 ± 0.19	1.18 ± 0.22	2.06 ± 0.24	0.64 ± 0.31		1.41 ± 0.24
star	6			0.97 ± 0.34	1.06 ± 0.27	0.56 ± 0.48	1.49 ± 0.22	2.19 ± 0.33	0.99 ± 0.28	2.08 ± 0.26	0.64 ± 0.17		
cal SD)	7			1.31 ± 0.25	1.44 ± 0.29			2.25 ± 0.24	1.19 ± 0.23	1.93 ± 0.30	0.74 ± 0.25		
analytical (2SD) pted meas	8			1.24 ± 0.24	1.03 ± 0.20			2.84 ± 0.24	1.36 ± 0.22	1.81 ± 0.29	0.49 ± 0.22		
ana	9				1.53 ± 0.26			1.73 ± 0.22	0.60 ± 0.25	2.03 ± 0.30	0.05 ± 0.37		
and	10							1.86 ± 0.22	0.99 ± 0.29		0.63 ± 0.36		
NBS28 and analytical standard devii (2SD) of all accepted measurements (%)	11												
δ ³⁰ Si _{NBS-28} a of all a	12												
30 Si	13												
·0	14												
Sessio	n	Br6	Br2	Br2	Br2	Brl	Br3	Br7	Br7	Br2	Br5	Br4v2	Br4
Sample o during the s		5	3	2	4	3	5	7	9	9	2	3	5

Sample		Ki40	Ki42	Ki43	Ki44	Ki46	Ki54	Ki48	Ki51	Ki15	Ki57	Ki58	Ki08
age		201.50	201.50	204.82	204.82	210.27	214.4	217.09	219.00	228.00	241.00	243.48	244.90
LS-mean (δ ³⁰ S and LS-SD (2 S		0.80 ± 1.06	1.40 ± 0.52	1.21 ± 0.52	1.43 ± 0.22	-0.27 ± 1.10	0.03 ± 0.97	1.02 ± 0.78	1.09 ± 0.69	1.10 ± 0.52	0.97 ± 0.78	0.61 ± 0.93	-0.20 ± 0.64
Number of measi	urements	5	10	6	9	10	6	5	6	10	10	6	10
Accepted measu	rements	5	10	6	9	10	6	4	6	10	9	6	10
Rejected measur	rements	0	0	0	0	0	0	1	0	0	1	0	0
п	1	-0.11 ± 0.18	1.47 ± 0.28	0.82 ± 0.24	1.44 ± 0.24	-0.57 ± 0.21	-0.12 ± 0.23	1.54 ± 0.22	0.51 ± 0.20	1.31 ± 0.35	0.65 ± 0.19	0.85 ± 0.23	0.27 ± 0.23
standard deviation urements (%)	2	0.88 ± 0.21	1.59 ± 0.29	1.03 ± 0.17	1.41 ± 0.31	0.83 ± 0.25	0.15 ± 0.33	0.63 ± 0.15	1.20 ± 0.19	1.31 ± 0.31	1.46 ± 0.26	0.91 ± 0.28	0.15 ± 0.20
evii %)	3	1.21 ± 0.20	1.38 ± 0.24	1.17 ± 0.26	1.30 ± 0.29	-1.06 ± 0.22	-0.67 ± 0.24	1.08 ± 0.32	1.36 ± 0.29	0.98 ± 0.29	1.23 ± 0.24	0.92 ± 0.24	-0.03 ± 0.23
d d	4	1.09 ± 0.17	1.37 ± 0.19	1.51 ± 0.23	1.26 ± 0.25	-0.62 ± 0.27	0.75 ± 0.21	0.91 ± 0.16	0.93 ± 0.25	1.14 ± 0.28	0.66 ± 0.25	0.90 ± 0.23	0.00 ± 0.20
ıdar	5	0.97 ± 0.18	0.76 ± 0.20	1.32 ± 0.27	1.43 ± 0.19	-0.01 ± 0.27	0.25 ± 0.27		1.45 ± 0.18	0.88 ± 0.24	1.54 ± 0.21	0.15 ± 0.26	-0.69 ± 0.18
star	6		1.38 ± 0.25	1.40 ± 0.20	1.45 ± 0.22	-0.24 ± 0.19	-0.16 ± 0.17		1.09 ± 0.24	1.04 ± 0.24	1.04 ± 0.23	-0.15 ± 0.27	-0.17 ± 0.27
(2SD) and analytical standard deviction (2SD) of all accepted measurements (%)	7		1.56 ± 0.25		1.63 ± 0.18	-0.02 ± 0.20				1.55 ± 0.20	0.45 ± 0.27		-0.34 ± 0.28
analytical (2SD) pted meas	8		1.56 ± 0.35		1.41 ± 0.26	0.05 ± 0.25				0.99 ± 0.18	0.67 ± 0.23		-0.21 ± 0.32
ana	9		1.67 ± 0.21		1.52 ± 0.21	-0.01 ± 0.26				1.25 ± 0.22	0.98 ± 0.29		-0.29 ± 0.26
nd cce	10		1.36 ± 0.23			-0.90 ± 0.20				0.67 ± 0.22			-0.64 ± 0.20
830Si _{NBS-28} and of all acce	11												
of a	12												
90 Si	13												
`%O	14												
Session		Br4	Br7	Br6	Br2	Br7	Brl	Br6	Br3	Br2	Br7	Br3	Br7
Sample ord during the se		1	3	4	8	5	5	2	4	5	1	7	4

Sampl	e	Ki07	Ki06	Ki06s	Ki05	Ki04	Ki3s	Ki03	Ki02	Ki01	Ki10	Ki09	
age		245.00	245.25	245.25	246.20	246.60	247.20	247.20	247.80	248.00	250.2	250.30	
LS-mean (δ ³⁰ and LS-SD (2		0.88 ± 0.42	0.03 ± 0.53	-0.15 ± 0.78	-0.26 ± 0.40	0.65 ± 0.67		0.21 ± 1.11	0.41 ± 0.85	0.33 ± 0.94	-0.24 ± 0.57	0.68 ± 0.65	Total
Number of mea	surements	6	6	14	6	9	8	10	7	10	6	9	266
Accepted meas	urements	6	6	14	6	9	0	10	7	10	6	9	252
Rejected meas	urements	0	0	0	0	0	8	0	0	0	0	0	14
u	1	1.11 ± 0.24	0.43 ± 0.19	-0.03 ± 0.39	-0.09 ± 0.49	0.75 ± 0.29		0.31 ± 0.26	0.86 ± 0.23	0.63 ± 0.27	-0.38 ± 0.26	0.33 ± 0.26	
analytical standard deviation (2SD) pted measurements (%)	2	0.96 ± 0.31	0.16 ± 0.28	0.02 ± 0.32	-0.37 ± 0.30	0.83 ± 0.19		0.17 ± 0.28	-0.16 ± 0.30	0.79 ± 0.13	-0.42 ± 0.25	0.80 ± 0.29	
18528 and analytical standard devi (2SD) of all accepted measurements (%)	3	0.79 ± 0.16	0.07 ± 0.20	0.16 ± 0.22	-0.46 ± 0.25	1.14 ± 0.23		0.73 ± 0.27	0.77 ± 0.22	0.71 ± 0.19	-0.02 ± 0.25	0.97 ± 0.37	
d d	4	1.14 ± 0.29	-0.10 ± 0.32	-0.19 ± 0.20	0.01 ± 0.25	0.59 ± 0.23		0.84 ± 0.33	0.52 ± 0.29	0.44 ± 0.21	-0.52 ± 0.28	0.26 ± 0.31	
ıdar	5	0.70 ± 0.25	-0.23 ± 0.18	0.11 ± 0.25	-0.39 ± 0.23	0.26 ± 0.24		0.08 ± 0.17	0.72 ± 0.25	-0.27 ± 0.30	0.34 ± 0.42	1.03 ± 0.26	
star	6	0.64 ± 0.26	-0.23 ± 0.36	0.24 ± 0.24	-0.14 ± 0.33	0.19 ± 0.16		-0.23 ± 0.18	0.23 ± 0.19	0.77 ± 0.21	-0.20 ± 0.30	0.35 ± 0.26	
lytical (2SD)	7			-0.24 ± 0.40		0.39 ± 0.28		0.73 ± 0.27	-0.16 ± 0.23	0.51 ± 0.19		0.72 ± 0.18	
lyti (28 d m	8			0.22 ± 0.47		0.83 ± 0.25		0.46 ± 0.34		-0.48 ± 0.16		0.52 ± 0.28	
ana pte	9			-0.23 ± 0.43		1.02 ± 0.34		0.43 ± 0.18		0.12 ± 0.18		1.15 ± 0.27	
nnd	10			0.14 ± 0.37				-1.00 ± 0.21		-0.14 ± 0.31			
28 6 28 6	11			-0.65 ± 0.20									
sav _i on s	12			-1.06 ± 0.20									
8 ³⁰ Si _{NBS-28} and of all acce	13			-0.09 ± 0.23									
8	14			-0.03 ± 0.29									
Session	n	Br3	Br3	Br5	Brl	Br2	Br2	Br7	Br3	Br7	Brl	Br2	
Sample o during the s		3	6	8	2	7	1	2	8	6	1	6	

Table A2 All the analytical dataset of the samples and a standard.

.2015											Yield	Yield	Yield	Yield	Yield	Yield	Yield												Yield				Yield	ppir																
Date: 03.09.2015		Comment	Setting: Standard	Setting: Standard	Setting: Standard	Setting: Standard	ng. standard dard	dard	dard	dard							ici	C.I.	dard	dard	dard	5 5	5 5	C1	50		22	52	ខ្លួ ខ្លួ	dard	Standard	Standard	3 3	7						dard	dard	Standard	dard							
	Ĺ		Setti	Setti	Setti	Setti	, 0,	0.33 Standard	Standard	Stan	Ki3S Ki3S	Ki3S	Ki3S	Ki3S	Ki3S Ki3S	Ki3S	Ki22CI	A 18 Standor	0.36 Standard	Standard	Stan	Ki22C1	Ki22CI	Ki22	Ki22CI	Ki22C	Ki22C2	Ki22C2	Ki22C2 Ki22C2		0.08 Standard Standard	Stan	Ki22C2	Ki21	Ki21	Ki21	Ki21	Ki21	Ki21 Ki21	0.04 Standard		Stan	Ki21	Kils	Ki15	Ki15	Kils	Kils	Ki15	
2σ)	uc	2SD						0.23	0.26	0.25								1.24		0.23	0.22	0.28	0.25	0.26	0.26	0.23	0.25	0.24	0.26	0.23		0.25		0.25	0.23	0.24	0.23	0.24	0.25			0.22	0.24	0.26	0.25	0.25	0.23	0.23	0.22	
Value= -0.13±0.02 (NBS-28, 2σ)	Calibration	830 Si NBS-28								-0.21							000	0.50	-0.37			0.90			0.95			0.63	1.01		60.0					1.50			1.42			0.07			1.29					
0.13±0.02		839					42.79	0.31										42.70	0.34											42.58	0.0									42.49	0.55									
Value= -	ection	2SD					0.30	0.23	0.33	0.30							000	0.20	0.30	0.25	0.20	0.39	0.28	0.34	0.34	0.24	0.28	0.27	0.33		0.25	0.30		0.29	0.21	0.28	0.24	0.27	0.29		0.23	0.18	0.26	0.35	0.31	0.29	0.28	0.24	0.00	
	Drift correction	830 Si					42.57	42.90	42.96	42.72								41.07	42.88	42.80	42.69	41.66	41.49	41.42	41.62	41.36	41.79	41.92	41.56	42.61	42.54	-42.54		41.43	41.51	41.91	4.14	41.54	41.17	42.40	42.11	42.59	42.67	41.29	41.29	41.61	41.45	41.55	41.06	
is.	mean	2SD	-42.66				-42.77	0.36		90 00	0.89						-41.43	42 60	0.40								-41.00	1.72		-42.57	0.08			-41.41	0.53					-42.49	0.64			-41.48	0.49					
Analyse: δ ³⁰ Si	emen fs	2SD int	0.32	0.26	0.31	0.33	0.30	0.23	0.33	0.30	0.34	0.41	0.32	0.36	0.33	0.41	0.29	0.70	0.30	0.25	0.20	0.39	0.28	0.34	0.34	0.24	0.28	0.27	0.31	0.22	0.25	0.30	0.35	0.29	0.21	0.28	0.24	0.27	0.20	0.28	0.23	0.18	0.26	0.35	0.31	0.29	0.28	0.24	900	0.20
An	Measurements	830 Si	42.75	42.55	42.71	42.58	42.55	42.89	42.95	42.71	40.93	-40.93	41.79	40.52	40.73	4 81.18	40.96	42.41	42.87	42.79	42.68	41.65	41 48	41.41	41.61	41.36	41.78	41.91	40.69	42.61	42.53	42.54	30.07	41.42	41.51	8 8	4.4	41.53	41.16	42.39	42.11	42.59	42.00	41.29	41.29	41.61	41.45	41.55	41.06	1.00
QI (Paine)	mean	2SD	3.1148E+07				3.0755E+07	7.4196E+04		2001000000	2.2818E+07						2.8729E+07	3.0675E+07	2.1453E+05								2.7029E+07	5.3019E+06		3.0837E+07	2.1480E+05			2.9310E+07	2.6665E+06					3.0838E+07	1.2775E+05			3.0009E+07	1.4397E+06					
Standard: UNIL-Q1 (Paine)	Yield	CPS/nA	3.1284E+07	3.1126E+07	3.1147E+07	3.1136E+07 3.1046E+07	3.0782E+07	3.0759E+07	3.0779E+07	3.0702E+07	2.2626E+07 2.1376E+07	2.1605E+07	2.4820E+07	2.3169E+07	2.31/3E+0/ 2.2285E+07	2.3487E+07	2.7525E+07	2.8813E+07	3.0657E+07	3.0533E+07	3.0729E+07	2.8094E+07	2.8049E+07	2.9583E+07	2.8062E+07	2.9511E+07	2.9368E+07	2.8892E+07	2.6714E+07 2.9436E+07	3.0988E+07	3.0/92E+0/ 3.0831E+07	3.0738E+07	2.4376E+07 2.3387E+07	2.9512E+07	2.9987E+07	3.0389E+07 2.7024E+07	2.9953E+07	2.9446E+07	2.7062E+07 2.9860E+07	3.0913E+07	3.0867E+07	3.0796E+07	3.0552E+07	2.9622E+07	2.9496E+07	3.0549E+07	3.0046E+07 3.1452E+07	3.0030E+07	7 00300107	Z. 0020ETU/
S		Cime	6:57	7:04	17:07	17:10	7:17	17:21	17:24	7.27	1734	17:37	17:40	7:44	17:50	17:53	75:71	0.00	18:07	18:10	18:13	18:17	18:23	18:26	18:30	8:36	18:40	18:43	18:46	18:53	95.81	19:03	90:61	19:13	9:16	9:19	19:26	19:29	19:32	9:39	19:42	19:45	9:52	55:61	65:61	20:02	20:05	20:12	21.0	50:12
SR2		2SD	.0604E-01	0647E-01			.0862E-01			.4673E-02				1.0313E-01			.6538E-02	0870E-01			0233E-01				.2168E-02								.6541E-02			.0358E-01			.6079E-02				6229E-02			.0459E-01			20145-01	
Mount: BR2	H'2 (28Si/Coeff)	2.5	1.060	1.064	1.171			_	1.212	9.467	2.2852E-01	5.7820E-02	2.0247E-01	1.031	3.1276E-01	7.846		ľ	_	9.8226E-02	1.023	2.2781E-01 5.6218E-02	1.291	8.8619E-02	3.216	8.058	1.106	6.6701E-01	9.5456E-02 7.9917E-02	1.053	9.4032E-02 9.7959E-02	1.033	8.654	8.5387E-02		7 145	8.4314E-02	6.0335E-02	5.607			6	8	-		1.045	8.611	7.704	1 201	
	H2 (CPS	2.3118E+06	2.3039E+06	2.3042E+06	2.3048E+06	2.2783E+06	2.2785E+06	2.2785E+06	2.2769E+06	1.6786E+06 1.5859E+06	1.6038E+06	1.8396E+06	1.7200E+06	1.7229E+06 1.6548E+06	1.7424E+06	2.0419E+06	2.1338E+06	2.2741E+06	2.2806E+06	2.2804E+06	2.0850E+06	2.0852E+06	2.1968E+06	2.0859E+06	2.1928E+06	2.1822E+06	2.1445E+06	1.9861E+06 2.1864E+06	2.2986E+06	2.2848E+06 2.2882E+06	2.2842E+06	1.8149E+06	2.1939E+06	2.2290E+06	2.2591E+06 2.0108E+06	2.2273E+06	2.1899E+06	2.0120E+06 2.2210E+06	2.2967E+06	2.2958E+06	2.2884E+06	2.2743E+06	2.2062E+06	2.1953E+06	2.2743E+06	2.2361E+06 2.3420E+06	2.2381E+06	20140511.0	2.1493E±00
	L'2 (30Si/Coeff)	2SD	1.1240E-01	1.1688E-01	1.1414E-01	1.3955E-01	1.1456E-01	1.2302E-01	1.2192E-01	1.0511E-01	2.2682E-01	5.6754E-02	2.0840E-01	1.0394E-01	3.1287E-01	7.4002E-02	2.5919E-02	1.0292E-01	1.2514E-01	1.0113E-01	9.9679E-02	2.2270E-01 5.8589E-02	1.3707E-01	9.6219E-02	2.6734E-02	8.3217E-02	1.2513E-01	6.6668E-01	9.8168E-02 8.3038E-02	1.0519E-01	8.9388E-02 9.7723E-02	1.0025E-01	7.9738E-02	8.2338E-02	8.4599E-02	1.0325E-01 2.1616E-01	8.9280E-02	6.4271E-02	5.9736E-02 1.7685E-01	1.0871E-01	1.0142E-01	9.8259E-02	9.2310E-02	1.2935E-01	1.6278E-01	1.0328E-01	8.4753E-02	8.5718E-02	1 21200 01	1.31332-01
ALYSES	L'2 (30)	CPS	7.0687E+07	7.0423E+07	7.0486E+07	7.0499E+07	6.9683E+07	6.9711E+07	6.9728E+07	6.9620E+07	5.1262E+07 4.8409E+07	4.8957E+07	5.6224E+07	5.2504E+07	5.2583E+07 5.0516E+07	5.3220E+07	6.2360E+07	6.32/0E+0/	6.9573E+07	6.9774E+07	6.9756E+07	6.3715E+07 6.5590E+07	6.3659E+07	6.7115E+07	6.3738E+07	6,6993E+07	6.6657E+07	6.5550E+07	6.0644E+07 6.6806E+07	7.0310E+07	6.9922E+07 6.9982E+07	6.9871E+07	5.5381E+07 5.3142E+07	6.7028E+07	6.8106E+07	6.9057E+07 6.1416E+07	6.8046E+07	6.6905E+07	6.1453E+07 6.7868E+07	7.0232E+07	7.0162E+07	7.0003E+07	6.9458E+07	6.7385E+07	6.7060E+07	6.9494E+07	6.8310E+0/ 7.1562E+07	6.8359E+07	6 SSORE+07	0.33300.07
SIMS ANALYSES	Si/28Si)	2SD	1.5872E-02	1.3079E-02	1.5435E-02	1.6394E-02	1.5181E-02	1.1378E-02	1.6388E-02	1.4874E-02	1.6859E-02	2.0690E-02	1.6079E-02	1.7839E-02	1.5645E-02	2.0530E-02	1.4319E-02	0.0477E-02	1.4823E-02	1.2259E-02	1.0243E-02	1.9482E-02	1.4120E-02	1.6827E-02	1.6874E-02	1.1850E-02	1.4179E-02	1.3497E-02	1.5328E-02 1.6302E-02	1.1050E-02	1.2444E-02 1.1138E-02	1.5243E-02	1.7302E-02 2.2939E-02	1.4682E-02	1.0343E-02	1.3917E-02 1.4509E-02	1.2205E-02	1.3732E-02	1.4288E-02	1.3770E-02	1.1614E-02	8.7517E-03	1.3202E-02	1.7317E-02	1.5466E-02	1.4656E-02	1.3983E-02 1.1931E-02	1.1754E-02	9 790KF_03	00 7000
	H'2/L'2 (30Si/28Si)	CPS	3.2687E-02	3.2694E-02	3.2688E-02	3.2693E-02 3.2688E-02	3.2694E-02	3.2682E-02	3.2680E-02	3.2688E-02	3.2766E-02	3.2749E-02	3.2720E-02	3.2763E-02	3.2756E-02 3.2756E-02	3.2740E-02	3.2748E-02	3.27.24E-02	3.2683E-02	3.2685E-02	3.2689E-02	3.2724E-02	3.2730E-02	3.2732E-02	3.2726E-02	3.2734E-02	3.2720E-02	3.2715E-02	3.2757E-02 3.2728E-02	3.2692E-02	3.2692E-02 3.2694E-02	3.2694E-02	3.2775E-02 3.2784E-02	3.2732E-02	3.2729E-02	3.2716E-02 3.2744E-02	3.2732E-02	3.2728E-02	3.2741E-02 3.2727E-02	3.2699E-02	3.2709E-02	3.2692E-02 3.2683E-02	3.2744E-02	3.2737E-02	3.2737E-02	3.2726E-02	3.2723E-02	3.2728E-02	3 2745E-02	20.47.47.47.6
	Beam	FII.	2.26	2.26	2.26	2.26	2.26	2.27	2.27	2.27	2.27	2.27	2.27	2.27	2.27	2.27	2.27	2.27	2.27	2.29	2.27	2.27	2.27	2.27	2.27	2.27	2.27	2.27	2.27	2.27	2.27	2.27	2.27	2.27	2.27	2.27	2.27	2.27	2.27	2.27	2.27	2.27	2.27	2.27	2.27	2.27	2.28	2.28	3 28	
			d30Si_030915_BR2_Paine_test@1	d30Si_030915_BR2_Paine_test@3	d30Si_030915_BR2_Paine_test@4	d30Si_030915_BR2_Paine_test@5 d30Si_030015_BR2_Paine_test@6	d30Si 030915 BR2 Paine@1	d30Si 030915 BR2 Paine@02	d30Si_030915_BR2_Paine@03	130Si 030915 BR2 Paine@04	d30Si_030915_Ki3S_rad@1 d30Si_030915_Ki3S_rad@2	d30Si_030915_Ki3S_rad@3	d30Si_030915_Ki3S_rad@4	d30Si_030915_Ki3S_rad@5	d30Si_030915_Ki3S_rad@6 d30Si_030915_Ki3S_rad@7	d30Si_030915_Ki3S_rad@8	430Si_030915_Ki22c1_rad@1	13051 030915 N12201 rati@2 d30Si 030915 BB2 Pain@05	d30Si 030915 BR2 Paine@06	d30Si_030915_BR2_Paine@07	d30Si_030915_BR2_Paine@08	d30Si_030915_Ki22cl_rad@3 d30Si_030015_Ki22cl_rad@4	d30Si 030915 Ki22c1 rad@5	d30Si_030915_Ki22c1_rad@6	d30Si_030915_Ki22cl_rad@7	130Si 030915 Ki22ci rad@9	d30Si_030915_Ki22C2_rad@1	d30Si_030915_Ki22C2_rad@2	d30Si_030915_Ki22C2_rad@3 d30Si_030915_Ki22C2_rad@4	d30Si_030915_BR2_Paine@09	d30Si_030915_BR2_Paine@10 d30Si_030915_BR2_Paine@11	130Si_030915_BR2_Paine@12	d30Si_030915_Ki22C2_rad@5 d30Si_030915_Ki22C2_rad@6	d30Si 030915 Ki21 rad@l	d30Si_030915_Ki21_rad@2	d30Si_030915_Ki21_rad@3 d30Si_030915_Ki21_rad@4	d30Si_030915_Ki21_rad@5	d30Si_030915_Ki21_rad@6	d30Si_030915_Ki21_rad@7 d30Si_030915_Ki21_rad@8	d30Si_030915_BR2_Paine@13	d30Si_030915_BR2_Paine@14	d30Si_030915_BR2_Paine@15 d30Si_030915_BR2_Paine@16	130Si 030915 Ki21 rad@9	d30Si_030915_Ki15_rad@l	d30Si_030915_Ki15_rad@2	d30Si_030915_Ki15_rad@3	d30Si_030915_Ki15_rad@4 d30Si_030915_Ki15_rad@5	d30Si_030915_Ki15_rad@6	d30Si 030915 Ki15 rad@7	

Table A2 Continued.

			SIMS AN	SIMS ANALYSES		Me	Mount: BR2		Standard: UNIL-QI (Paine)	QI (Paine)	Ans	Analyse: 8 ³⁰ Si		V.	nlue= -0.1	3±0.02 (N	Value= -0.13±0.02 (NBS-28, 2σ)		Date: 03.09.2015
	Beam4	H'2/L'2 (30Si/28Si)	30Si/28Si)	L'2 (308)	L'2 (30Si/Coeff)	H'2 (28Si/Coeff)	(Coeff)	Time	Yield CBS/n 4	mean	Measurements	١,	mean L	Drift correction	E 5	Calibr	Calibration		Comment
d30Si 030915 BR2 Paine@17	2.27	3.2690E-02	1.4568E-02	7.0136E+07	1.1794E-01	2.2941E+06	1.0669E-01	20:25	3.0836E+07	3.0799E+07			L	42.67 0.	29 42.59		15 0.25	-0.07	Standard
d30Si_030915_BR2_Paine@18	2.28	3.2688E-02	1.8037E-02	7.0093E+07	1.1699E-01	2.2925E+06	1.0701E-01	20:28	3.0800E+07	1.3591E+05	42.71		0.27 -4;	42.71 0.	36 0.23			0.24	Standard
d30Si_030915_BR2_Paine@19	2.28	3.2698E-02	1.1392E-02	7.0237E+07	1.0615E-01	2.2967E+06	1.0721E-01	20:32	3.0857E+07		42.41	0.23	4.		0.23	0.12	2 0.23		Standard
d30Si 030915 BRZ Pane@20 d30Si 030915 Ki15 rad@10	2.28	3.2716E-02	1.5/41E-02	6.9531E+07	1.0497E-01	2.2759E+06	9.9959E-02	20:38	3.0703E+07		42.57	0.22	4 4	41.90 0.	0.22	-0.04	5 0.23		Standard Ci15
d30Si 030915 Ki9 rad@1	2.28	3.2705E-02	1.3044E-02	7.0936E+07	1.2251E-01	2.3214E+06	1.0837E-01	20:42	3.1151E+07	3.0274E+07	42.23	0.26 -4	41.89 4.	ľ	0.26	0.31	1 0.24		Ki09
d30Si_030915_Ki9_rad@2	2.28	3.2720E-02	1.4574E-02	6.7386E+07	7.8828E-02	2.2049E+06	7.7565E-02	20:45	2.9604E+07	1.6946E+06	41.78				0.29	0.7			Ki09
d30Si_030915_Ki9_rad@3	2.28	3.2725E-02	1.8691E-02	6.5120E+07	1.1842E-01	2.1314E+06	1.1876E-01	20:48	2.8592E+07		41.62	0.37	4		0.37	0.95			6019
d30Si_030915_Ki9_rad@4	2.28	3.2702E-02	1.5312E-02	7.0892E+07	1.2606E-01	2.3185E+06	1.2108E-01	20:51	3.1112E+07		42.29	0.31	4.		0.31	0.25			60!5
d30Si_030915_K19_rad@5 d30Si_030915_K19_rad@6	2.28	3.2727E-02 3.2705E-02	1.3002E-02	6.7699E+07 7.0346E+07	1.1528E-01	2.2158E+06 2.3019E+06	1.1386E-01	20:55	2.9729E+07 3.0867E+07		41.56	0.26	4 4	41.56 0.	0.26	1.01	0.24		Ki09
d30Si 030915 Ki9 rad@7	2.28	3.2717E-02	9.1153E-03	6.9233E+07	9.0624E-02	2.2649E+06	8.9704E-02	21:01	3.0376E+07		41.86	0.20	i 4		0.18	0.70			6012
d30Si 030915 Ki9 rad@8	2.28	3.2711E-02	1.4062E-02	7.0284E+07	8.1807E-02	2.2993E+06	8.1119E-02	21:05	3.0846E+07		45.04	0.28	4		0.28	0.51			60!3
d30Si_030915_Ki9_rad@9	2.28	3.2732E-02	1.3680E-02	6.8839E+07	1.1557E-01	2.2530E+06	1.1352E-01	21:08	3.0184E+07		41.44	0.27	4		0.27	1.14			60iX
d30Si_030915_BR2_Paine@21	2.28	3.2681E-02	1.0822E-02	7.1908E+07	9.6591E-02	2.3502E+06	9.7210E-02	21:11	3.1578E+07	3.1513E+07	42.92							-0.27	Standard
d30Si_030915_BR2_Paine@22	2.28	3.2691E-02	1.4090E-02	7.1814E+07	9.0667E-02	2.3477E+06	9.1274E-02	21:14	3.1505E+07	1.0345E+05	42.63		0.24 4.		0.28 0.21			0.22	Standard
d30Si_030915_BR2_Paine@23	2.28	3.2686E-02	1.1573E-02	7.1704E+07	1.0805E-01	2.3449E+06	9.7910E-02	21:18	3.1452E+07		42.78	0.23	4.		0.23	-0.26	26 0.23		Standard
d3051 030915 BK2 Pane@24	2.78	3.2684E-02	1.5058E-02	/.1842E+0/	9.66/4E-02	2.5484E+06	9.4/8/E-02	17:17	3.151/E+0/	20:00000	47.83				97	40.51			Standard
d30Si_030915_Ki4C_rad@1 d30Si_030915_Ki4C_rad@2	2.28	3.2718E-02	1.4400E-02 9.5208E-03	6.7128E+07 6.9043E+07	9.9781E-02 1.3916E-01	2.1963E+06 2.2605E+06	9.6489E-02	21:24	2.9444E+07 3.0302E+07	3.0239E+07	41.83	0.29	4 191 4	41.82 0.41.75 0.	0.29	0.74	0.25		Ki04C
d30Si 030915 Ki4C rad@3	2.28	3.2731E-02	1.1254E-02	6.7751E+07	9.2481E-02	2.2172E+06	8.8627E-02	2131	2.9706E+07	00.000	41.45				0.23	1.13			Si04C
d30Si_030915_Ki4C_rad@4	2.28	3.2713E-02	1.1513E-02	6.8764E+07	1.1598E-01	2.2495E+06	1.1234E-01	21:34	3.0172E+07		41.98	0.23	4		0.23	0.58			G04C
d30Si_030915_Ki4C_rad@5	2.28	3.2702E-02	1.1848E-02	6.9922E+07	1.6186E-01	2.2870E+06	1.6041E-01	21:38	3.0691E+07		-42.30	0.24	4	42.29 0.	0.24	0.24			Gi04C
d30Si_030915_Ki4C_rad@6	2.28	3.2700E-02	8.0270E-03	7.0885E+07	9.0174E-02	2.3180E+06	8.9241E-02	21:41	3.1081E+07		42.36	0.16	4		0.16	0.18			Ki04C
d30Si_030915_Ki4C_rad@7	2.28	3.2706E-02	1.3764E-02	6.9897E+07	9.2811E-02	2.2859E+06	9.5888E-02	21:44	3.0652E+07		42.17	0.28	4		0.28	0.38			Ki04C
d30Si_030915_Ki4C_nad@8	2.28	3.2721E-02	1.2281E-02	6.9777E+07	8.4784E-02	2.2829E+06	8.6294E-02	21:47	3.0591E+07		41.75	0.25	4.	41.74 0.	0.25	0.82	2 0.23		Ki04C
d3031 030913 N14C rad(@9	2.78	3.2727E-02	1.0/03E-02	0.7343E+07	9.0880E-02	2.2040E+06	9.4344E-02	1017	2.950/E+0/		/6.14	0.34	4 .		34	0.1			C104C
d30Si 030915 K144 rad(@)	2.28	3.2741E-02	1.1908E-02	6.8848E+07	8.6897E-02	2.2544E+06	8.7865E-02	21:54	3.0182E+07	3 1416E±07	41.16	0.24	4 60 67	41.15 0.	0.24	1.43	3 0.23	91.0	Ki44
d30Si 030915 BR2 Paine@26	2.20	3.2687E-02	9.2350E-03	7 1687F+07	1 0528E-01	2 3435E±06	1.0246F-01	22:01	3.1438E+07	7 5919E+04	42.74							0.33	Standard
d30Si 030915 BR2 Paine@27	2.28	3.2698E-02	1.4460E-02	7.1556E+07	1.0853E-01	2.3397E+06	1.0437E-01	22:04	3.1370E+07		42.43				0.29	0.11		0.00	Standard
d30Si_030915_BR2_Paine@28	2.28	3.2688E-02	7.0230E-03	7.1697E+07	9.2215E-02	2.3435E+06	8.8595E-02	22:07	3.1401E+07		42.72	0.14	4		0.14	-0.19			Standard
d30Si_030915_Ki44_rad@2	2.28	3.2740E-02	1.5265E-02	6.9974E+07	1.1253E-01	2.2910E+06	1.1307E-01	22:10	3.0655E+07	3.0551E+07	41.19		~		31	1.40			ζi44
d30Si_030915_Ki44_rad@3	2.28	3.2736E-02	1.4482E-02	7.1225E+07	8.6454E-02	2.3326E+06	7.7928E-02	22:14	3.1193E+07	8.0769E+05	41.30		0.21 4		0.29	1.29			Çi 44
d30Si_030915_Ki44_rad@4	2.28	3.2735E-02	0.2657E-02	7.0045E+07	1.2242E-01	2.2931E+06	1.2202E-01	22:17	3.0685E+07		41.34	0.25	4 -	41.33 0.	0.25	1.25	5 0.24		Ci44
d30Si 030915 Ki44 rad@6	2.20	3.2741E-02	1 1069E-02	6.8689E+07	1 2902E-01	2.2506E+06	1 1969E-01	22.20	3.0079E+07		5 4	0.22	1.4		0.22	1 44			5.44
d30Si 030915 Ki44 rad@7	2.28	3.2747E-02	8.9239E-03	7.0431E+07	1.0452E-01	2.3063E+06	1.0159E-01	22:27	3.0847E+07		40.98	0.18	4		0.18	1.62			G44
d30Si_030915_Ki44_rad@8	2.28	3.2740E-02	1.2774E-02	7.0208E+07	8.7631E-02	2.2976E+06	8.0694E-02	22:30	3.0739E+07		41.20	0.26	4		0.26	1.40			Çi 44
d30Si 030915 Ki44 rad@9	2.29	3.2743E-02	1.0382E-02	6.8420E+07	1.3881E-01	2.2401E+06	1.3814E-01	22:33	2.9940E+07		41.09	0.21	4 .	41.08 0.	7.21	1.51	1 0.23		Çi 44
d30Si 030915 RED Paine@29	2.28	3.2680E-02	1.2319E-02	7.1696E+07	9.8828E-02	2.344E+06	9.1310E-02	22:40	3.1391E+07	3.1377E+07	42.94	0.25	42.76 47		25 42.75	٩	12 0.23	-0.23	Nandard
d30Si_030915_BR2_Paine@30	2.28	3.2687E-02	1.3720E-02	7.1770E+07	1.0328E-01	2.3458E+06	1.0042E-01	22:44	3.1429E+07	1.3094E+05	42.73							0.23	Standard
d30Si_030915_BR2_Paine@31	2.28	3.2687E-02	1.5268E-02	7.1711E+07	9.6995E-02	2.3443E+06	9.6941E-02	22:47	3.1408E+07		42.75	0.31	4		0.31	-0.22			Standard
d30Si_030915_BR2_Paine@32	2.28	3.2691E-02	1.0132E-02	7.1428E+07	9.8129E-02	2.3351E+06	9.5767E-02	22:50	3.1282E+07		42.63				0.20	-0.10			Standard
d30Si_030915_Ki35_rad@2	2.28	3.276E-02	1.1402E-02	6.8/56E+0/	1.0508E-01	2.252/E+06	1.0399E-01	22.53	3.0152E+0/	2.98/6E+0/	40.42	0.23	40.67	40.41 0.	0.23	2.21	0.23		Ki35
d30Si 030915 Ki35 rad@4	2.20	3.2744E-02	9.3645E-03	6.8504E+07	1.00/4E-01	2.2396E+06	1.8210E-01	23:00	3.0233E+07	1.04926700	40.38				0.30	0.7			N35
d30Si_030915_Ki35_rad@5	2.28	3.2761E-02	1.2068E-02	6.6329E+07	1.5829E-01	2.1746E+06	1.4430E-01	23:03	2.9096E+07		40.58	0.24	4		0.24	2.05			Ci35
d30Si_030915_Ki35_rad@6	2.28	3.2762E-02	1.3199E-02	6.9467E+07	1.1818E-01	2.2759E+06	1.1377E-01	23:07	3.0459E+07		40.56	0.26	4		0.26	2.07			Ç135
d30Si_030915_Ki35_rad@7	2.28	3.2757E-02	1.4762E-02	6.6260E+07	1.0846E-01	2.1716E+06	1.0019E-01	23:10	2.9057E+07		40.70	0.30	4		0.30	1.92			Ki35
d30Si_030915_Ki35_rad@8	2.28	3.2753E-02	1.4295E-02	6.7238E+07	1.5922E-01	2.2023E+06	1.5517E-01	23:13	2.9482E+07		40.81	0.29	4 -	40.80 0.	0.29	1.80	0 0.25		Ki35
d30Si 030915 RB2 Paine@33	2.28	3.2690E-02	1.5042E-02	7.1276E+07	8.5477E-02	2.3301E+06	8.8889E-02	23:20	3.1269E+07	3.1133E+07	42.66		42.65 47		30 42.64	1 7		-0.12	NISS
d30Si_030915_BR2_Paine@34	2.28	3.2681E-02	1.2069E-02	7.1028E+07	1.0906E-01	2.3212E+06	1.0489E-01	23:23	3.1115E+07	2.0383E+05	42.93				0.24 0.39	99 -0.40			Standard
d30Si_030915_BR2_Paine@35	2.28	3.2690E-02	1.2324E-02	7.1001E+07	1.3126E-01	2.3212E+06	1.2931E-01	23:27	3.1124E+07		42.65	0.25	4	42.63 0.	25	-0.1	11 0.23		Standard
d30Si 030915 BR2 Paine@36	2.28	3.2700E-02	8.2229E-03	7.0813E+07	1.1254E-01	2.3154E+06	1.0918E-01	23:30	3.1022E+07		42.37	0.16	4	42.36 0.	91	0.13	8 0.22		Standard

Table A2 Continued.

			SIMS ANALYSES	ALYSES		M	Mount: BR3		Standard: UNIL-QI (Paine)	C-QI (Paine)	Ana	Analyse: 8 ³⁰ Si		À	alue= -0.1	Value= -0.13±0.02 (NBS-28, 2σ)	BS-28, 2c	5		Date: 03.09.2015
	Beam	H'2/L'2 (30SV/28S CPS 2.	30Si/28Si) 2SD	L'2 (30SVCoc	31/Coeff) 2SD	H'2 (28SI/Coeff) CPS 2	/Coeff) 2SD	Time	Yield CPS/nA	mean 2SD	Measurements	į	mean 2SD	Drift correction 530 St	uo OS	C C C C C C C C C C C C C C C C C C C	Calibration 2SD	٥	Con	Comment
d30Si 030915 BR3 Paine test@1	2.95	3.2675E-02	6.2872E-03	1.1213E+08	1.0747E-01	3.6642E+06	1.0556E-01	10:05	3.7981E+07	3.7351E+07	43.09	Г		7	7	0	00.30		Setting	Setting: Standard
d30Si_030915_BR3_Paine_test@2	2.96	3.2682E-02	1.2070E-02	1.1171E+08	6.2295E-02	3.6510E+06	6.7105E-02	10:09	3.7698E+07	7.5902E+05	42.88		0.30						Setting	Setting: Standard
d30Si_030915_BR3_Paine_test@3 d30Si_030015_BP3_Paine_test@3	2.97	3.2682E-02	1.0184E-02 0.6006E-03	1.1100E+08	9.7157E-02	3.6278E+06	9.1043E-02	10:12	3.7420E+07 3.7307E+07		42.88	0.20							Setting	Setting: Standard
d30Si 030915 BR3 Paine test@5	2.97	3.2675E-02	1.1150E-02	1.1050E+08	1.5044E-01	3.6109E+06	1.4508E-01	10:18	3.7217E+07		43.08	0.22							Setting	Setting: Standard
d30Si_030915_BR3_Paine_test@6	2.97	3.2676E-02	7.6194E-03	1.1095E+08	1.0389E-01	3.6256E+06	9.9872E-02	10:22	3.7352E+07		43.07	0.15							Setting	Setting: Standard
d30Si_030915_BR3_Paine_test@7	2.97	3.2685E-02	1.0739E-02 8 3007E-03	1.0979E+08	1.0918E-01	3.5888E+06	1.0592E-01	10:25	3.6941E+07		42.79	0.21							Setting	Setting: Standard
d30Si_030915_BR3_Paine@1	2.24	3.2688E-02	1.5603E-02	7.9842E+07	1.2759E-01	2.6100E+06	1.2215E-01	10:32	3.5719E+07	3.5859E+07	42.70			42.79 0.	31 42	42.83 -0.07	0.23	3 -0.11		Jamaia
d30Si_030915_BR3_Paine@02	2.24	3.2685E-02	1.5305E-02	8.0251E+07	1.0616E-01	2.6242E+06	1.0085E-01	10:35	3.5820E+07	2.2364E+05	42.79		0.31							T.
d30Si_030915_BR3_Paine@03 d30Si_030915_BR3_Paine@04	2.24	3.2692E-02 3.2680E-02	1.2761E-02 1.0213E-02	8.0502E+07 8.0475E+07	9.5218E-02 1.1060E-01	2.6318E+06 2.6301E+06	9.7118E-02 1.1363E-01	10:39	3.5950E+07 3.5937E+07		42.96	0.26	1 4	42.67 0. 43.03 0.	0.26 0.20	0.05	5 0.21	- 0	Standard	
d30Si 030915 BR3 Paine@05	2.24	3.2687E-02	1.1033E-02	8.0389E+07	1.1222E-01	2.6277E+06	1.1142E-01	11:21	3.5880E+07	3.5835E+07	42.74	ľ	42.77 4			42.82 -0.08			S	
d30Si_030915_BR3_Paine@06	2.24	3.2691E-02	1.6327E-02	8.0645E+07	1.1874E-01	2.6364E+06	1.2532E-01	11:25	3.5958E+07	2.6308E+05	42.62		9						S	
d30Si_030915_BR3_Paine@07	2.24	3.2677E-02	9.0856E-03	7.9925E+07	1.5800E-01	2.6120E+06	1.5538E-01	11:28	3.5649E+07		43.03	0.18	7		0.18	-0.38		6	Standard	
d30Si 030915 BR3 Paine@08	2.24	3.2689E-02	7.7881E-03	8.0391E+07	1.0209E-01	2.6293E+06	9.3148E-02	11:31	3.5852E+07	3 40¢1E±07	42.68	0.16	1 00		0.16	10.0		6	Standard	
d30Si 030915 Ki7C rad@2	2.24	3.2721E-02	1.5353E-02	7.7458E+07	3.820/E-02 1.4446E-01	2.5345E+06	1.4418E-01	821	3.4547E+07	7.5457E+05	4 4 4 76	0.31	0.41	8 4 4 4 8 9	0.31	0.96	0.23	- 69	Ki07C	
d30Si_030915_Ki7C_rad@3	2.24	3.2715E-02	8.0328E-03	7.8936E+07	9.3491E-02	2.5827E+06	9.2580E-02	11:45	3.5226E+07		41.92				0.16	0.79		6	Ki07C	
d30Si_030915_Ki7C_rad@4	2.24	3.2726E-02	1.4500E-02	7.8267E+07	9.9890E-02	2.5626E+06	9.2018E-02	11:48	3.4901E+07		41.59	0.29	7		0.29	1.14		2	Ki07C	
d30Si_030915_Ki7C_rad@5 d30Si_030915_Ki7C_rad@6	2.24	3.2712E-02 3.2710E-02	1.2513E-02 1.3116E-02	7.8019E+07	2.2485E-01	2.5518E+06 2.6070E+06	2.2597E-01 1.1933E-01	11:51	3.4775E+07 3.5563E+07		42.02	0.25	1 9	42.05 0. 42.10 0	0.25	0.70	0 0.21		Ki07C	
d30Si 030915 Ki51 rad@1	2.24	3.2706E-02	1.0172E-02	7.9344E+07	9.1960E-02	2.5949E+06	8,9846E-02	11:58	3.5395E+07	3.4445E+07	42.20				20	0.5		. 0	Ki51	
d30Si_030915_Ki51_rad@2	2.24	3.2728E-02	9.6286E-03	7.6583E+07	1.4323E-01	2.5063E+06	1.4759E-01	12:01	3.4135E+07	1.0735E+06	41.54	0.19	0.64	41.57 0.	0.19	1.20	0 0.19	6 (Ki51	
d30Si 030915 R13 rango d30Si 030915 BR3 Paine@09	2.24	3.2693E-02	1.0410E-02	8.084E+07	1.0599E-01	2.5422E+06	1.0371E-01	12:04	3.6022E+07	3.6101E+07	42.57	0.21	42.73	42.60 0.	21 42	42.75 0.13	3 0.20		03 Standard	
	2.24	3.2686E-02	1.1547E-02	8.1105E+07	9.3516E-02	2.6511E+06	9.4209E-02	12:11	3.6137E+07	1.0794E+05	42.76			3 62	0.23 0.2			0 0.21		
d30Si_030915_BR3_Paine@11	2.24	3.2687E-02	1.1975E-02	8.1047E+07	1.0351E-01	2.6506E+06	9.9416E-02	12:14	3.6134E+07		42.73	0.24	7 `		0.24	40.04	0.21		Standard	71.
430Si 030915 BK3 Paine@12	2.24	3.2683E-02	1.2928E-02	8.1028E+07	1.0004E-01	2.0498E+06	9.4833E-02	12:17	3.4478E+07		42.85	0.26		42.8/ 0.	97	0.16			Standar	
d30Si_030915_Ki51_rad@5	2.25	3.2736E-02	8.9637E-03	7.6079E+07	1.1530E-01	2.4919E+06	1.1045E-01	12:24	3.3880E+07		41.31	0.18	1 1		0.18	1.45		. 6	Ki51	
d30Si_030915_Ki51_rad@6	2.24	3.2724E-02	1.2074E-02	7.6651E+07	1.6499E-01	2.5084E+06	1.6341E-01	12:27	3.4151E+07		41.66	0.24			0.24	1.09		-	Ki51	
d30Si_030915_Ki24_rad@l	2.24	3.2754E-02	1.2907E-02	7.6934E+07	1.1669E-01	2.5197E+06	1.1309E-01	12:30	3.4283E+07	3.3452E+07	41.04	0.26	40.92	40.78 0.	0.26	2.02	0.21		Ki24	
d30Si_030915_Ki24_rad@3	2.24	3.2749E-02	1.3585E-02	7.4489E+07	1.3498E-01	2.4395E+06	1.3067E-01	12:37	3.3209E+07	1.3202E-100	40.92				0.27	78.1		2 7	Ki24	
d30Si_030915_Ki24_rad@4	2.24	3.2759E-02	1.0536E-02	7.5011E+07	8.4256E-02	2.4570E+06	7.9608E-02	12:40	3.3439E+07		40.64	0.21	1		0.21	2.16		0	Ki24	
Ki24	2.26	3.2751E-02	8.9260E-03	7.3293E+07	9.4002E-02	2.4002E+06	9.5443E-02	12:43	3.2450E+07		40.88	0.18	1 `	40.88 0.41.20	0.18	1.92	0 0	90.	Ki24	
d30Si 030915 Ki6C rad@1	2.24	3.2702E-02	9.3909E-03	7.7473E+07	7.5322E-02	2.5335E+06	7.3156E-02	12:50	3.4541E+07		42.31	0.19	114	0	61	0.4	0	6	Ki06C	
d30Si_030915_BR3_Paine@13	2.24	3.2676E-02	9.1282E-03	7.9346E+07	1.0639E-01	2.5929E+06	1.0458E-01	12:53	3.5373E+07	3.5520E+07	43.07	ľ				42.88 -0.3				
d30Si_030915_BR3_Paine@14	2.24	3.2689E-02	8.7227E-03	7.9790E+07	9.5323E-02	2.6068E+06	1.0172E-01	12:57	3.5556E+07	1.9670E+05	42.70		0.30					9 0.28		
d30Si_030915_BR3_Paine@15 d30Si_030915_BR3_Paine@16	2.24	3.2682E-02 3.2683E-02	1.3738E-02 9.0427E-03	7.9844E+07 7.9789E+07	9.7867E-02 1.0031E-01	2.6107E+06 2.6075E+06	9.1314E-02 9.8651E-02	13:00	3.5576E+07 3.5574E+07		42.89	0.27	1 9	42.89 0. 42.86 0	0.27	91.0	18 0.22	7 0	Standard	
d30Si 030915 Ki6C rad@2	2.24	3.2693E-02	1.4200E-02	7.8499E+07	1.0089E-01	2.5676E+06	8.9339E-02	13:06	3.4985E+07	3.4695E+07	42.57		42.71		0.28	0.16		5 2	Ki06C	
d30Si_030915_Ki6C_nad@3	2.24	3.2690E-02	1.0032E-02	7.8042E+07	1.1918E-01	2.5512E+06	1.1967E-01	13:10	3.4788E+07	8.4980E+05	42.66				0.20	0.07		0	Ki06C	
d30Si_030915_Ki6C_nad@4	2.25	3.2684E-02	1.5786E-02	7.9072E+07	1.0154E-01	2.5856E+06	8.9306E-02	13:13	3.5219E+07		42.82	0.32	7 `	42.81 0.	0.32	-0.10	10 0.23	en c	Ki06C	
d30Si_030915_Ki6C_rad@6	2.25	3.2680E-02	1.7941E-02	7.7819E+07	1.1470E-01	2.5429E+06	1.2079E-01	13:20	3.4654E+07		42.95	0.36	. 4		0.36	-0.23		, vo	Ki06C	
d30Si_030915_Ki56_rad@l	2.24	3.2715E-02	1.1438E-02	7.6875E+07	7.1230E-02	2.5149E+06	6.6858E-02	13:23	3.4250E+07	3.3596E+07	41.92		L		0.23	0.85		0	Ki58	
d30Si_030915_Ki56_rad@2 d30Si_030915_Ki56_rad@3	2.24	3.2717E-02 3.2717E-02	1.3821E-02 1.1866E-02	7.3754E+07	1.3/3/E-01	2.4525E+06 2.4132E+06	1.3439E-01	13:26	3.3398E+07	1.4770E+06	8 8	0.28	0.92	4 24 24 20 0	0.28	0.92		7 -	K158 K158	
d30Si_030915_Ki56_rad@4	2.25	3.2716E-02	1.1655E-02	7.3258E+07	8.1070E-02	2.3967E+06	7.6710E-02	13:33	3.2630E+07		41.88	0.23	1		0.23	06:0	0		Ki58	
d30Si 030915 BR3 Paine@17	2.24	3.2687E-02	1.3222E-02	8,0028E+07	9.0278E-02	2.5031E+06 2.6159E+06	8.8983E-02	13:39	3.5658E+07	3.5626E+07	42.75								NISS Standard	
d30Si_030915_BR3_Paine@18	2.25	3.2672E-02	1.1292E-02	7.9880E+07	1.0023E-01	2.6100E+06	9.8988E-02	13:42	3.5556E+07	1.0604E+05	43.19		0.37 4			0.32 -0.46		0 0.33		-
d30Si_030915_BR3_Paine@19	2.25	3.2679E-02	1.5750E-02	7.9964E+07	9.2994E-02	2.6131E+06	1.0240E-01	13:46	3.5616E+07		42.99	0.31	1 `	42.96 0.	0.31	-0.25	25 0.23	en =	Standar	
d30Si 030915 Ki56 rad@6	2.24	3.2682E-02	1.3729E-02	7.7046E+07	1.2286E-01	2.5182E+06	1.1980E-01	13:52	3.4324E+07		42.90	0.27	1		27	0.1	0	. 2	Ki58	
d30Si_030915_Ki2C_rad@1	2.24	3.2715E-02	1.1563E-02	7.7323E+07	1.5357E-01	2.5296E+06	1.5306E-01	13:56	3.4454E+07	3.4314E+07	41.93	0.23			23	98'0		1	Ki02C	
d30Si_030915_Ki2C_rad@2	2.25	3.2682E-02	1.4893E-02	8.0727E+07	9.4518E-02 6.8005E-02	2.6383E+06 2.4060E+06	9.3060E-02	13:59	3.5942E+07	2.1155E+06	42.90		0.83	42.87 0.	0.30	0.16	16 0.23	m c	Ki02C	
d30Si_030915_Ki2C_rad@4	2.25	3.2703E-02	1.4432E-02	7.5308E+07	1.9525E-01	2.4630E+06	1.9113E-01	14:05	3.3532E+07		42.26	0.29	4		0.29	0.52		. 61	Ki02C	
d30Si_030915_Ki2C_rad@5	2.25	3.2710E-02	1.2445E-02	7.6289E+07	1.0249E-01	2.4955E+06	1.0129E-01	14:09	3.3968E+07		42.07	0.25	7		0.25	0.72		_	Ki02C	
d30Si_030915_Ki2C_rad@6 d30Si_030915_Ki2C_rad@7	2.25	3.2694E-02 3.2681E-02	9.5069E-03	7.7190E+07 7.9063E+07	1.2376E-01 1.0516E-01	2.5238E+06 2.5837E+06	1.2561E-01 1.0263E-01	14:12	3.4374E+07 3.5202E+07		42.54	0.19	1 4	42.50 0. 42.87 0	0.19	0.23	3 0.19	6 -	Ki02C	
d30Si_030915_BR3_Paine@21	2.25	3.2689E-02	1.2409E-02	7.9822E+07	1.0844E-01	2.6092E+06	1.0585E-01	14:25	3.5529E+07	3.5461E+07	42.69	ľ				42.81 0.08		1 -0.09		T
d30Si_030915_BR3_Paine@22	2.25	3.2680E-02	1.1089E-02	7.9602E+07	1.0520E-01	2.6029E+06 2.6030E+06	9.9791E-02	14:29	3.5394E+07 3.5448E+07	1.1169E+05	42.94	0.22	0.25	42.88 0.	0.22 0.2	21 -0.17				71. 7
d30Si_030915_BR3_Paine@24	2.25	3.2683E-02	1.3000E-02	7.9762E+07	1.0126E-01	2.6068E+06	9.8114E-02	14:35	3.5472E+07		42.86									
d30Si_030915_BR3_Paine@25 d30Si_030915_BR3_Paine@26	2.25	3.2691E-02 3.2678E-02	9.2987E-03 9.6762E-03	7.9703E+07 7.9991E+07	1.3082E-01	2.6055E+06 2.6141E+06	1.2737E-01 1.1492E-01	15:11	3.5441E+07 3.5546E+07	3.5550E+07 1.6123E+05	42.64	- 61.0	42.91 4	42.56 0.	0.19 42	42.83 0.17	7 0.19	60.0- 6	09 Standard	T. T.
d30Si_030915_BR3_Paine@27	2.25	3.2679E-02	1.0628E-02	8.0073E+07	9.0828E-02	2.6179E+06	8.1637E-02	15:18	3.5582E+07		42.98									
d30Si_030915_BR3_Paine@28	2.25	3.2678E-02	1.2869E-02	8.0209E+07	8.7631E-02	2.6212E+06	8.9838E-02	15:21	3.5632E+07		43.00	0.26	1		26	-0.21		1	Standar	

Table A2 Continued.

			SIMS AN	SIMS ANALYSES		W	Mount: BR4		Standard: UNIL-Q1 (Paine)	L-Q1 (Paine)	An	Analyse: δ^{30} Si			/alue= -0.	Value= -0.13±0.02 (NBS-28, 2σ)	NBS-28, 2σ)		Date: 03.09.2015	015
	Beam	H'2/L'2 (30Si/28Si)	(0Si/28Si)	L'2 (30SVCoeff)	W.Coeff)	H'2 (28Si/Coeff)	i/Coeff)		Yield	mean	Measurements		mean	Drift correction	ion		Calibration		,	
	nA	CPS	2SD	CPS	2SD	CPS	2SD	TIME	CPS/nA	2SD	830 Si	2SD int	2SD	830 Si 2	2SD	630 Si NBS-28	JBS-28 2SD		Соттеп	
d30Si_020915_Paine@1	2.82	3.2523E-02	9.9294E-03	7.4151E+07	2.1783E-01	2.4112E+06	2.1018E-01	10:02	2.6325E+07	3.0863E+07	47.54		-46.82						Setting: Standard	
d30Si_020915_Paine@2	2.82	3.2528E-02	1.0860E-02	7.3971E+07	2.3800E-01	2.4060E+06	2.3489E-01	10:05	2.6188E+07	8.7974E+06	47.40		0.84						Setting: Standard	
d30Si_020915_Paine@3	2.82	3.2544E-02	1.7757E-02	7.4083E+07	1.8241E-01	2.4107E+06	1.7446E-01	10:09	2.6229E+07		46.94	0.36							Setting: Standard	
d30Si_020915_Paine@4	2.83	3.2535E-02	1.3506E-02	7.4297E+07	2.2129E-01	2.4177E+06	2.1739E-01	10:12	2.6295E+07		47.20	0.27							Setting: Standard	
d30Si_020915_Paine@5	2.83	3.2546E-02	1.2153E-02	7.4337E+07	2.2347E-01	2.4195E+06	2.1606E-01	10:15	2.6308E+07		46.88	0.24							Setting: Standard	
d30Si_020915_Paine@6	2.82	3.2552E-02	1.0820E-02	9.8091E+07	1.2170E-01	3.1949E+06	1.1625E-01	10:23	3.4741E+07		46.71	0.22							Setting: Standard	
d30Si_020915_Paine@7	2.83	3.2551E-02	9.7748E-03	9.7926E+07	9.5872E-02	3.1892E+06	8.5702E-02	10:26	3.4611E+07		46.73	0.20							Setting: Standard	
d30Si_020915_Paine@8	2.83	3.2561E-02	1.2064E-02	9.8059E+07	9.5963E-02	3.1943E+06	8.4903E-02	10:29	3.4689E+07		46.45	0.24							Setting: Standard	
d30Si_020915_Paine@9	2.83	3.2558E-02	8.7009E-03	9.8186E+07	9.7307E-02	3.1983E+06	8.7008E-02	10:32	3.4729E+07		46.51	0.17							Setting: Standard	
d30Si_020915_Paine@10	2.83	3.2568E-02	9.8810E-03	9.8148E+07	8.3126E-02	3.1948E+06	8.6428E-02	10:36	3.4674E+07		46.22	0.20							Setting: Standard	
d30Si_020915_Paine@11	2.83	3.2560E-02	8.2523E-03	9.8191E+07	9.1561E-02	3.1971E+06	8.8840E-02	10:39	3.4705E+07		46.47	0.17							Setting: Standard	
d30Si_020915_Paine@12	2.82	3.2582E-02	9.3217E-03	9.7986E+07	8.6879E-02	3.1940E+06	7.8282E-02	11:13	3.4772E+07	3.4669E+07	45.81	- 61.0	-45.85	45.63 0	. 19 A	45.68 -0.1	-0.15 0.22	-0.20	Standard	
d30Si_020915_Paine@13	2.83	3.2581E-02	1.0729E-02	9.4161E+07	1.1472E-01	3.0658E+06	1.0770E-01	11:16	3.3318E+07	1.9675E+06	45.85	0.21	0.14	45.67 0	0.21 0	0.13 -0.1	19 0.23	0.14	Standard	
d30Si 020915 Paine@14	2.83	3.2583E-02	1.1800E-02	9.8710E+07	1.1136E-01	3.2164E+06	1.1121E-01	11:19	3.4912E+07		45.80	0.24		45.63 0	0.24	9	0.15 0.23		Standard	
d30Si_020915_Paine@15	2.83	3.2577E-02	1.2392E-02	1.0100E+08	3.3931E-02	3.2902E+06	3.0999E-02	11:22	3.5673E+07		45.95	0.25		45.79 0	0.25	-0	0.32 0.23		Standard	
d30Si_020915_Ki40C_rad@1	2.83	3.2584E-02	8.7786E-03	9.4593E+07	1.2279E-01	3.0822E+06	1.2206E-01	11:26	3.3434E+07	3.2967E+07	45.74	- 81.0	-44.86	45.59 0	0.18	-0-	-0.11 0.22		Ki40	
d30Si_020915_Ki40C_rad@2	2.83	3.2617E-02	1.0446E-02	9.4750E+07	7.9341E-02	3.0916E+06	6.9655E-02	11:29	3.3468E+07	9.9949E+05	44.79	0.21	1.02	44.65 0	0.21	3.0	0.88 0.23		Ki40	
d30Si_020915_Ki40C_rad@3	2.83	3.2628E-02	9.7511E-03	9.3534E+07	1.4252E-01	3.0516E+06	1.3927E-01	11:32	3.3012E+07		44.47	0.20		44.33 0	0.20	1.2			Ki40	
d30Si_020915_Ki40C_rad@4	2.83	3.2624E-02	8.3011E-03	9.1656E+07	6.7558E-02	2.9904E+06	6.2500E-02	11:35	3.2376E+07		44.58	0.17	-	44.45 0	0.17	1.0			Ki40	
d30Si_020915_Ki40C_rad@5	2.83	3.2621E-02	9.2252E-03	9.2147E+07	1.2059E-01	3.0057E+06	1.2020E-01	11:39	3.2544E+07		-44.69	0.18		44.56 0	0.18	0.97	97 0.22		Ki40	
d30Si_020915_Ki40C_mat@l	2.83	3.2614E-02	1.2897E-02	9.0044E+07	1.3905E-01	2.9367E+06	1.3680E-01	11:42	3.1794E+07	2.9199E+07	-44.87	ľ	-44.35	-44.75 0	0.26	0.77			Ki40 matrix	
d30Si_020915_Ki40C_mat@2	2.83	3.2636E-02	1.0807E-02	7.8346E+07	7.9853E-02	2.5568E+06	8.0175E-02	11:45	2.7665E+07	3.9851E+06	44.22		- 68.0		0.22	1.4			Ki40 matrix	Yield
d30Si_020915_Ki40C_mat@3	2.83	3.2627E-02	1.5059E-02	8.4163E+07	2.1239E-01	2.7463E+06	2.1605E-01	11:48	2.9732E+07		44.49	0.30	*		0.30	11			Ki40 matrix	
d30Si_020915_Ki40C_mat@4	2.83	3.2651E-02	1.2098E-02	7.8254E+07	8.0917E-02	2.5548E+06	8.3633E-02	11:52	2.7605E+07		43.81	0.24		43.72 0	0.24	1.8	1.85 0.23		Ki40 matrix	Yield
d30Si_020915_Paine@16	2.83	3.2588E-02	1.0207E-02	1.0062E+08	9.4110E-02	3.2789E+06	9.6070E-02	12:08	3.5502E+07	3.5259E+07	45.63	0.20	- 45.69						Standard	
d30Si_020915_Paine@17	2.84	3.2580E-02	9.9793E-03	1.0088E+08	1.5463E-01	3.2869E+06	1.5225E-01	12:11	3.5575E+07	8.2022E+05	45.87	0.20	0.37		0.20 0	0.21 -0.3	0.34 0.22	0.22	Standard	
d30Si_020915_Paine@18	2.84	3.2582E-02	8.9222E-03	1.0008E+08	6.8048E-02	3.2607E+06	6.5209E-02	12:14	3.5287E+07		45.82	0.18		45.77 0	0.18	9	0.30 0.22		Standard	
d30Si_020915_Paine@20	2.84	3.2597E-02	1.2129E-02	9.9828E+07	1.4368E-01	3.2562E+06	1.3573E-01	12:57	3.5204E+07	3.4480E+07	45.37	Ċ							Standard	
d30Si_020915_Paine@21	2.84	3.2600E-02	1.3150E-02	9.5795E+07	1.7153E-01	3.1230E+06	1.6685E-01	13:00	3.3759E+07	1.2667E+06	45.28		0.18			0.15 0.1		0.16	Standard	
d30Si_020915_Paine@22	2.84	3.2604E-02	1.0883E-02	9.7063E+07	1.0209E-01	3.1647E+06	1.0152E-01	13:03	3.4197E+07		45.17	0.22	-	45.23 0	0.22	0.2			Standard	
d30Si_020915_Paine@23	2.84	3.2598E-02	1.1110E-02	9.8760E+07	1.0897E-01	3.2210E+06	1.0148E-01	13:07	3.4760E+07		-45.33	0.22		45.41 0	0.22	7:0	0.08 0.23		Standard	
d30Si_020915_Ki39C_rad@1	2.84	3.2652E-02	1.3611E-02	9.3237E+07	1.7241E-01	3.0444E+06	1.7475E-01	13:29	3.2797E+07	3.2782E+07	-43.76	0.27	-44.00	43.89 0	0.27	1.6	1.68 0.24		Ki39	
d30Si_020915_Ki39C_rad@2	2.84	3.2641E-02	1.0819E-02	9.2177E+07	1.2077E-01	3.0086E+06	1.1730E-01	13:33	3.2415E+07	1.2128E+06	44.10	0.22	0.49	44.23 0	0.22	1.3	1.31 0.23		Ki39	
d30Si_020915_Ki39C_rad@3	2.84	3.2651E-02	7.4558E-03	9.1870E+07	9.1450E-02	2.9996E+06	9.2586E-02	13:36	3.2327E+07		43.80	0.15	-	43.94 0	0.15	1.6			Ki39	
d30Si_020915_Ki39C_rad@4	2.84	3.2632E-02	8.6803E-03	9.6095E+07	1.1948E-01	3.1375E+06	1.0888E-01	13:39	3.3820E+07		44.36	0.17	,	44.51 0	0.17	1.6			Ki39	
d30Si_020915_Ki39C_rad@5	2.84	3.2644E-02	1.1935E-02	9.2526E+07	1.5894E-01	3.0205E+06	1.5687E-01	13:42	3.2553E+07		-43.99	0.24	,	44.14 0	0.24	1.4	1.41 0.23		Ki39	
d30Si_020915_Paine@24	2.84	3.2598E-02	1.0019E-02	9.9604E+07	1.0829E-01	3.2469E+06	1.0848E-01	13:46	3.5060E+07	3.4594E+07	-45.36	0.20	-45.56 -		0.20 -4		-0.04 0.22	-0.26	Standard	
d30Si_020915_Paine@25	2.84	3.2588E-02	1.0454E-02	9.9646E+07	1.7489E-01	3.2474E+06	1.7248E-01	13:49	3.5030E+07	1.1051E+06	45.65		0.29			0.26 -0.3		0.27	Standard	
d30Si_020915_Paine@26	2.85	3.2587E-02	8.8288E-03	9.6531E+07	1.6169E-01	3.1456E+06	1.5969E-01	13:52	3.3917E+07		45.68	0.18			0.18	0	_		Standard	
d30Si_020915_Paine@27	2.85	3.2591E-02	1.1541E-02	9.7847E+07	9.1926E-02	3.1903E+06	8.7533E-02	13:55	3.4368E+07		45.55	0.23		45.73 0	0.23	.0-	-0.26 0.23		Standard	

Table A2 Continued.

			SIMS AN	SIMS ANALYSES		Mo	Mount: BR4v2		Standard: UNIL-QI (Paine)	L-Q1 (Paine)	Ana	Analyse: δ^{30} Si			Value= -0.13±0.02 (NBS-28, 2σ)	3±0.02 (Nì	BS-28, 2σ	-	Date: 03.09.2015
	Beam	H'2/L'2 (30Si/28Si)	0Si/28Si)	L'2 (30Si/Coeff	:/Coeff)	H'2 (28Si/Coeff)	/Coeff)	Ē	Yield	mean	Measurements	nen fs	mean	Drift correction	ction	Ü	Calibration		
	nA	CPS	2SD	CPS	2SD	CPS	2SD	TIME	CPS/nA	2SD	830 Si 2	2SD int	2SD (830 Si	2SD	630 Si NRS-28	S-28 2SD	9	Comment
d30Si_040915_BR4_Paine@1	2.33	3.2677E-02	1.1111E-02	8.4303E+07	1.4469E-01	2.7567E+06	1.3319E-01	0	3.6219E+07	3.5641E+07	43.04	0.22	-43.01						Setting: Standard
d30Si_040915_BR4_Paine@2	2.34	3.2691E-02	7.3868E-03	8.1704E+07	1.1866E-01	2.6711E+06	1.1937E-01	_	3.4961E+07	2.6970E+06	42.63	0.15	0.78						Setting: Standard
d30Si_040915_BR4_Paine@3	2.34	3.2677E-02	9.2090E-03	8.2091E+07	1.5683E-01	2.6826E+06	1.5533E-01	7	3.5121E+07		43.04	0.18							Setting: Standard
d30Si_040915_BR4_Paine@4	2.34	3.2693E-02	1.1562E-02	8.1632E+07	1.1860E-01	2.6690E+06	1.1802E-01	3	3.4904E+07		42.56	0.23							Setting: Standard
d30Si_040915_BR4_Paine@5	2.34	3.2676E-02	1.4900E-02	7.4776E+07	1.6760E-01	2.4436E+06	1.6393E-01	4	3.1937E+07		43.07	0.30							Setting: Standard
d30Si_040915_BR4_Paine@6	2.34	3.2659E-02	1.2601E-02	8.7057E+07	1.1632E-01	2.8433E+06	1.1725E-01	S	3.7203E+07		43.56	0.25							Setting: Standard
d30Si_040915_BR4_Paine@7	2.34	3.2679E-02	7.0994E-03	8.3225E+07	1.5934E-01	2.7219E+06	1.4642E-01	9	3.5509E+07		42.99	0.14							Setting: Standard
d30Si_040915_BR4_Paine@8	2.34	3.2680E-02	7.7632E-03	8.0416E+07	2.1591E-01	2.6282E+06	2.1209E-01	7	3.4298E+07		42.95	0.16							Setting: Standard
d30Si_040915_BR4_Paine@9	2.34	3.2679E-02	1.2674E-02	8.3395E+07	1.2314E-01	2.7236E+06	1.3337E-01	∞	3.5578E+07		42.97	0.25							Setting: Standard
d30Si_040915_BR4_Paine@10	2.34	3.2644E-02	1.3700E-02	8.6099E+07	1.9825E-01	2.8106E+06	1.9444E-01	6	3.6740E+07		43.99	0.27							Setting: Standard
d30Si_040915_BR4_Paine@11	2.35	3.2679E-02	7.9642E-03	8.5974E+07	1.6549E-01	2.8095E+06	1.6395E-01	10	3.6659E+07		42.96	0.16							Setting: Standard
d30Si_040915_BR4_Paine@12	2.34	3.2657E-02	1.4912E-02	8.8997E+07	1.9070E-01	2.9089E+06	1.7753E-01	Ξ	3.8079E+07		43.62	0.30							Setting: Standard
d30Si_040915_BR4_Paine@13	2.35	3.2684E-02	9.0542E-03	8.2865E+07	1.2373E-01	2.7085E+06	1.2587E-01	12	3.5333E+07		-42.83	0.18							Setting: Standard
d30Si_040915_BR4_Paine@14	2.35	3.2686E-02	8.3286E-03	8.4266E+07	9.1881E-02	2.7544E+06	9.0038E-02	13	3.5931E+07		42.78	0.17							Setting: Standard
d30Si_040915_BR4_Paine@15	2.35	3.2694E-02	9.2168E-03	8.3456E+07	1.3326E-01	2.7285E+06	1.3149E-01	14	3.5589E+07		42.53	0.18							Setting: Standard
d30Si_040915_BR4_Paine@16	2.35	3.2677E-02	1.5127E-02	8.5898E+07	1.3879E-01	2.8047E+06	1.5102E-01	15	3.6618E+07		43.03	0.30							Setting: Standard
d30Si_040915_BR4_Paine@17	2.35	3.2689E-02	9.5313E-03	8.2581E+07	1.1661E-01	2.6993E+06	1.1507E-01	16	3.5216E+07		42.69	0.19							Setting: Standard
d30Si_040915_BR4_Paine@18	2.34	3.2679E-02	9.5366E-03	8.5453E+07	1.4558E-01	2.7923E+06	1.4702E-01	17	3.6583E+07	3.6642E+07	42.98	0.19	-43.12 -	42.93 (0.19 43.07	.07 0.07	7 0.40	80.0- 0	38 Standard
d30Si_040915_BR4_Paine@19	2.35	3.2661E-02	1.0937E-02	8.6477E+07	1.5850E-01	2.8244E+06	1.5749E-01	18	3.6868E+07	1.3429E+06	43.52	0.22	0.82	43.47 (0.22 0.71	71 -0.4	9 0.40	0 0.74	4 Standard
d30Si_040915_BR4_Paine@20	2.35	3.2665E-02	8.3444E-03	8.7634E+07	1.7846E-01	2.8648E+06	1.6951E-01	16	3.7359E+07		43.38	0.17		43.33	0.17	-0.35		0	Standard
d30Si_040915_BR4_Paine@21	2.35	3.2692E-02	1.0079E-02	8.3962E+07	8.1061E-02	2.7449E+06	7.9766E-02	20	3.5757E+07		42.61	0.20		42.56	0.20	0.45	5 0.40	0	Standard
d30Si_040915_BR4_Paine@22	2.35	3.2678E-02	9.5927E-03	8.4321E+07	1.5606E-01	2.7554E+06	1.5549E-01	31	3.5888E+07	3.6211E+07	43.02	0.19	-43.08 -		0.19 43.	43.08 -0.01	1 0.40		99 Standard
d30Si_040915_BR4_Paine@23	2.35	3.2684E-02	8.4275E-03	8.4676E+07	1.1396E-01	2.7693E+06	1.0541E-01	32	3.6004E+07	1.8631E+06	45.84	0.17	08.0	42.83	0.17 0.76	76 0.17	7 0.40	0 0.79	9 Standard
d30Si_040915_BR4_Paine@24	2.35	3.2687E-02	1.0581E-02	8.5300E+07	1.6291E-01	2.7880E+06	1.6437E-01	33	3.6262E+07		42.74	0.21	08.0	42.73	0.21	0.28	8 0.40	0	Standard
d30Si_040915_BR4_Paine@25	2.35	3.2659E-02	1.1782E-02	8.9236E+07	1.2595E-01	2.9145E+06	1.2747E-01	34	3.7931E+07		43.56	0.24		43.55	0.24	-0.58	8 0.41	_	Standard
d30Si_040915_BR4_Paine@26	2.35	3.2651E-02	7.1539E-03	8.8410E+07	1.8994E-01	2.8868E+06	1.9097E-01	35	3.7664E+07		43.81	0.14			0.14	-0.85	5 0.39	6	Standard
d30Si_040915_BR4_Paine@27	2.35	3.2683E-02	1.7097E-02	8.3575E+07	1.3612E-01	2.7317E+06	1.3510E-01	36	3.5514E+07		42.86	0.34		42.86	0.34	0.15	5 0.42	2	Standard
d30Si_040915_BR4_Paine@28	2.35	3.2659E-02	1.1533E-02	8.6054E+07	1.5429E-01	2.8105E+06	1.5585E-01	37	3.6589E+07		43.55	0.23			0.23	-0.59	9 0.40	0	Standard
d30Si_040915_BR4_Paine@29	2.35	3.2686E-02	1.3047E-02	8.3492E+07	1.0558E-01	2.7291E+06	1.0150E-01	38	3.5498E+07		42.76	0.26		42.77	0.26	0.24	4 0.41	_	Standard
d30Si_040915_BR4_Paine@30	2.35	3.2682E-02	1.1241E-02	8.2751E+07	1.2243E-01	2.7060E+06	1.1355E-01	39	3.5183E+07		42.89	0.22			0.22	0.10	0.40	0	Standard
d30Si_040915_BR4_Paine@31	2.35	3.2686E-02	1.0208E-02	8.3726E+07	1.3262E-01	2.7367E+06	1.3139E-01	40	3.5581E+07		-42.78	0.20		42.79	0.20	0.22	2 0.40	0	Standard
d30Si_040915_Ki41_rad@1	2.36	3.2720E-02	1.0150E-02	7.7345E+07	1.3637E-01	2.5306E+06	1.3666E-01	46	3.2841E+07	3.3730E+07	41.76			41.80	0.20	1.25)	0	Ki41
d30Si_040915_Ki41_rad@2	2.35	3.2729E-02	1.8727E-02	7.7343E+07	6.1451E-02	2.5317E+06	6.4292E-02	50	3.2853E+07	3.0611E+06	41.51	0.37	1.32		1.64		1.72	2	Ki41 intenal error
d30Si_040915_BR4_Paine@32	2.35	3.2681E-02	9.9304E-03	8.2620E+07	1.4261E-01	2.7002E+06	1.4438E-01	51	3.5093E+07	3.5617E+07	-42.90		_			_			10 Standard
d30Si_040915_BR4_Paine@33	2.36	3.2673E-02	1.0927E-02	8.4653E+07	1.0648E-01	2.7661E+06	1.0690E-01	52	3.5935E+07	7.4899E+05	43.16		0.22		0.22 0.19			0 0.20	0 Standard
d30Si_040915_BR4_Paine@34	2.36	3.2678E-02	1.1001E-02	8.3915E+07	1.2060E-01	2.7420E+06	1.2043E-01	53	3.5610E+07		43.01	0.22			0.22	-0.07		0	Standard
420C; 040015 DD4 Daim@35	200	00 0000000	1 11000 00	TO 1471 D.	00 10000	2 750 AEL OK	00 310000	6.4	2 50205.07		40 10			13 15		21.0	0100		Chandond

Table A2 Continued.

99.2015								duplicate										Yield																																	
Date: 03.09.2015	Comment		Setting: Standard	Setting: Standard Setting: Standard	Setting: Standard	Setting: Standard	Standard	Standard	Standard	Standard	Standard	Standard	Standard	Standard	Ki48	Ki48 Ki48	Ki48	Ki48	Standard	Standard	Standard	Standard	Standard	Standard	Ki43	Ki43	Ki43	Ki43	Ki43	Standard	Standard	Standard	Ki20	Ki20	Ki20	Ki20 Ki20	Standard	Standard	Standard	Standard	Standard	Standard Standard	Standard	Standard	Standard	Standard	Standard	Standard	Standard	Standard	Standard Standard
								0.22	-			0.30						П	0.13		•		0.51								1.22							0.72			0.50			1.05			0.22			0.29	
28, 2σ)	7	7SD					0.34		0.34	0.34	0.35	0.34	0.34	0.33	0.34	0.36	0.33		0.34	0.34	0.34	0.36	0.34	0.35	0.35	0.34	0.35	0.34	0.34	0.34	0.34	0.36	0.36	0.35	0.35	0.34	0.34	0.33	0.34	0.34	0.34	0.34	0.33	0.35	0.33	0.34	0.36	0.34	0.33	0.33	0.34
Value= -0.13±0.02 (NBS-28, 2σ)	Calibration	6" Si NBS-28					-0.10		0.15	0.03	0.04	0.02	-0.20	0.09	1.62	0.70	0.99		0.14	0.24	0.05	0.21	0.43	ç =	68'0	1.10	1.24	1.58	1.47	0.43	-1.15	0.25	3.07	2.20	2.59	1.62	-0.03	0.37	0.02	90.0	0.08	0.25	-0.23	-1.09	0.22	0.01	-0.12	0.10	-0.03	-0.13	0.25
-0.13±0.0		٥					45.23	0.21			45 33	0.29							45.37	90.0		45.40	0.49							45.41	1.17						45.54	69.0		45.39	0.47		45.46	1.00		45.28	0.21		45.23	0.28	
Value=	rection	asz					0.20		0.22	0.22	0.26	0.20	0.21	0.13	0.22	0.15	0.16		0.19	0.23	0.20	0.29	0.22	0.28	0.24	0.17	0.26	0.23	0.20	0.23	0.23	0.22	0.31	0.26	0.27	0.19	0.21	0.17	0.21	0.21	0.21	0.17	0.14	0.24	0.23	0.17	0.29	0.19	0.16	0.16	0.23
	Drift correction	8Si					45.34		45.09	45.27	45.27	45.22	45.43	45.16	43.69	4 4 5	44.29		45.37	45.01	45.19	45.03	45.65	45.34	44.39	44.19	44.06	43.73	43.83	44.83	46.33	45.48	42.31	43.14	42.77	43.69	45.27	45.59	45.22	45.18	45.16	45.47	45.45	46.28	45.02	45.23	45.35	45.14	45.26	45.36	45.00
.Si	mean	ZSD	-45.10	0.24			-45.25	0.25			45.34	0.33			-44.19	0.73			45.38	ì		-45.41	0.56		-44.02	0.49				-45.41	1.35						-45.54	0.80		-45.38	0.55		-45.44	1.16		-45.27	0.24		-45.21	0.32	
Analyse: δ^{30} Si	Measurements	2SD int	0.21	0.23	0.19	0.22	0.20		0.22	0.22	0.20	0.20	0.21	0.13	0.22	0.15	0.16		0.19	0.23	0.20	0.29	0.22	0.28	0.24	0.17	0.26	0.23	0.20	0.23	0.23	0.33	0.31	0.26	0.27	0.19	0.21	0.17	0.21	0.21	0.21	0.21	0.14	0.24	0.14	0.17	0.29	0.19	0.16	0.16	0.23
A	Measu	8. Si	45.29	44.97	45.21	45.04	45.36		45.11	45.29	45.29	45.24	45.45	45.17	43.71	8 4 4	44.31	-9558.22	45.38	45.02	45.20	45.04	45.66	45 34	44.40	44.19	44.06	43.73	43.84	44.83	46.33	45.48	42.31	43.14	42.77	43.69	45.26	45.59	45.21	45.17	45.15	45.75	45.44	46.26	45.06	45.22	45.34	45.40	45.24	45.34	44.97
L-QI (Paine)	mean	asz.	3.4162E+07	1.3037E+00			3.3782E+07	1.9693E+06			3 4004E±07	3.4004E+0/ 1.0669E+06			2.4983E+07	2.8041E+0/			3.4504E+07			3.3866E+07	1.3777E+06		3.1679E+07	2.0334E+06				3.2103E+07	2.3901E+06						3.5215E+07	2.3817E+06		3.4917E+07	2.1810E+06		3.4381E+07	1.0468E+06		3.4870E+07	1.5840E+06		3.4243E+07	1.6072E+06	
Standard: UNIL-Q1 (Paine)	Yield	CPS/nA	3.4493E+07	3.3884E+07	3.4484E+07	3.4875E+07	3.2819E+07		3.3690E+07	3.5151E+07	3.3468E+07	3.3824E+07	3.3856E+07	3.3557E+07	3.1866E+07	3.19/4E+0/ 3.1989E+07	2.9085E+07	1.7166E+02	3.4495E+07	3.3491E+07	3.4055E+07	3.3601E+07	3.4868E+07	3.3299E+07	3.1737E+07	3.3169E+07	3.1432E+07	3.0004E+07	3.1930E+07	3.1410E+07	3.0869E+07	3.2607E+07	2.5376E+07	2.6136E+07	2.3702E+07	2.9319E+07 2.7745E+07	3.4895E+07	3.4498E+07	3.4488E+07	3.4537E+07	3.4146E+07	3.6555E+07 3.4451E+07	3.3816E+07	3.5037E+07	3.452E+07	3.4612E+07	3.3868E+07	3.5583E+07 3.5420E+07	3.4734E+07	3.5064E+07	3.3300E+07
S	Time		15:10	15:17	15:20	15:23	15:48	15:48	15:51	15:54	800	1624	16:27	16:30	16:34	16:40	16:43	16:47	16:50	16:57	17:00	17:26	17:29	17:36	17:39	17:42	17:46	17:49	17:57	00:81	18:04	18:10	18:14	18:17	18:20	18:23	18:30	18:33	18:40	19:03	90:61	19:09	19:35	19:38	19:42	20:08	20:11	20:14	20:40	20:44	20:50
Mount: BR6	ş		7.4661E-02			.9022E-01	6920E-01			3535E-01	1224E-01			1709E-01	.3635E-02	.8353E-01 .4161E-01	5.3755E-02	.1698E-02	1.7664E-01		.2870E-02	.0780E-01	1.6556E-01	9103E-02	L	.1630E-01	.4815E-01	.8712E-01	2973E-01			.0608E-01				8100E-01 5697E-01		.8266E-01			.9789E-02				2910E-02 0752E-02			9.7777E-02 6.6900E-02			2.808/E-01 5.2194E-02
Moun	H'2 (28Si/Coeff)					- ,	. 1				- -			_				4	- ΄			1	_ 0		-	_			-	1	m -	- (*)	-	6			1			1	× -			en 1	0 0						
	Н	CPS	3.2019E+06	3.1569E+06	3.2103E+06	3.2501E+06	3.0549E+06		3.1457E+06	3.2838E+06	3.1253E+06	3.1624E+06	3.1640E+06	3.1381E+06	2.9829E+06	2.9898E+06 2.9926E+06	2.7198E+06	-7.6538E+03	3.2258E+06		3.1853E+06	3.1459E+06	3.2639E+06	3.1163E+06	2.9743E+06	3.1111E+06	2.9489E+06	2.8158E+06	2.9997E+06	2.9426E+06	2.8908E+06	3.0508E+06	2.3846E+06	2.4536E+06	2.2250E+06	2.7526E+06 2.6037E+06	3.2686E+06	3.2328E+06	3.2339E+06	3.2372E+06	3.2024E+06	3.2274E+06	3.1697E+06	3.2843E+06	3.2357E+06	3.2449E+06	3.1774E+06	3.3430E+06 3.3270E+06	3.2640E+06	3.2919E+06	3.1829E+06 3.1295E+06
	L'2 (30Si/Coeff)	2SD	8.3010E-02	9.7800E-02	7.8345E-02	1.9120E-01	1.8584E-01		1.3948E-01	1.5093E-01	1.2286E-01	1.2312E-01	1.3454E-01	1.1832E-01	7.4821E-02	1.8806E-01	5.4489E-02		1.9022E-01	9.7992E-02	9.6057E-02	1.1339E-01	1.6617E-01	1.105/E-01	1.9092E-01	1.2148E-01	1.5164E-01	1.8871E-01	1.2289E-01	1.6610E-01	3.3713E-01	3.2507E-01	1.1359E-01	9.7037E-02	1.0142E-01	1.7955E-01 1.5535E-01	1.3549E-01	1.8276E-01	1.2055E-01	1.3592E-01	9.2263E-02	3.7047E-01	3.1926E-01	3.1313E-01	5.8/66E-02 6.1553E-02	8.6408E-02	1.5305E-01	1.0588E-01 7.4907E-02	1.0896E-01	8.9550E-02	2. /802E-01 5.6955E-02
ALYSES	L'2 (30	CPS	9.8177E+07	9.6759E+07	9.8461E+07	9.9675E+07	9.3629E+07		9.6410E+07	1.0067E+08	9.5810E+07	9.7008E+07	9.7065E+07	9.6249E+07	9.1341E+07	9.1638E+07	8.3345E+07	4.9264E+02	9.8864E+07	9.6092E+07	9.7703E+07	9.6472E+07	1.0016E+08	9.536/E+07	9.1151E+07	9.5318E+07	9.0341E+07	8.6235E+07	9.1817E+07	9.0220E+07	8.8765E+07	9.62/0E+0/ 9.3602E+07	7.2862E+07	7.5096E+07	6.8071E+07	8.4555E+07 7.9734E+07	1.0025E+08	9.9192E+07	9.9135E+07	9.9222E+07	9.8211E+07	1.0499E+08 9.9013E+07	9.7245E+07	1.0084E+08	9.8269E+07 9.9229E+07	9.9529E+07	9.7471E+07	1.0251E+08 1.0199E+08	1.0007E+08	1.0098E+08	9.7611E+07 9.6003E+07
SIMS ANALYSES	Si/28Si)	asz.	1.0308E-02	8.4777E-03 1.1375E-02	9.7271E-03	1.1222E-02	9.7991E-03		1.0866E-02	1.1102E-02	1.3121E-02 0.0747E-03	9.9/42E-03 9.6423E-03	1.0272E-02	6.4968E-03	1.0835E-02	7.7468E-03	7.9662E-03		9.3871E-03	1.1687E-02	9.7614E-03	1.4716E-02	1.1020E-02	1.4101E-02	1.1986E-02	8.4439E-03	1.2908E-02	1.1564E-02	1.0058E-02	1.1356E-02	1.1604E-02	1.1234E-02 1.6649E-02	1.5311E-02	1.3194E-02	1.3627E-02	8.62/8E-03 9.5962E-03	1.0628E-02	8.2813E-03	1.0416E-02	1.0537E-02	1.0568E-02	8.6040E-03 1.0620E-02	7.1932E-03	1.2160E-02	7.0475E-03	8.5709E-03	1.4648E-02	9.4263E-03 1.1674E-02	8.0255E-03	7.9395E-03	1.1262E-02 8.7302E-03
	H'2/L'2 (30Si/28Si)	CPS	3.2600E-02	3.2608E-02 3.2611E-02	3.2603E-02	3.2609E-02	3.2598E-02		3.2606E-02	3.2600E-02	3.2600E-02	3.2592E-02 3.2602E-02	3.2595E-02	3.2604E-02	3.2654E-02	3.2624E-02 3.2639E-02	3.2634E-02	-2.9223E-01	3.2597E-02	3.2609E-02	3.2603E-02	3.2609E-02	3.2587E-02	3.2369E-02 3.2598E-02	3.2631E-02	3.2637E-02	3.2642E-02	3.2653E-02 3.2647E-02	3.2650E-02	3.2616E-02	3.2564E-02	3.2594E-02	3.2702E-02	3.2674E-02	3.2686E-02	3.2642E-02 3.2655E-02	3.2601E-02	3.2590E-02	3.2603E-02	3.2604E-02	3.2605E-02	3.2585E-02 3.2594E-02	3.2595E-02	3.2567E-02	3.2610E-02 3.2608E-02	3.2603E-02	3.2598E-02	3.2596E-02 3.2606E-02	3.2602E-02	3.2598E-02	3.2600E-02
	Beam	nA	2.85	2.89	2.86	2.86	2.85	duplicate	2.86	2.86	2.86	2.87	2.87	2.87	2.87	2.87	2.87	2.87	2.87	2.87	2.87	2.87	2.87	2.87	2.87	2.87	2.87	2.87	i 5 i 88	2.87	2.88	2.87	2.87	2.87	2.87	2.88	2.87	2.88	2.87	2.87	2.88	2.87	2.88	2.88	2.87	2.88	2.88	5 5.88 5 88 7 88	2.88	2.88	2.88
			430Si_020915_BR6_Paine@1	usosi_020915_BR6_Faine@z d30Si_020915_BR6_Paine@3	d30Si_020915_BR6_Paine@4	d30Si 020915 BR6 Paine@5	130Si 020915 BR6 Paine@9	d30Si_020915_BR6_Paine@9	d30Si_020915_BR6_Paine@10	d30Si_020915_BR6_Paine@11	130Si 020915 BR6 Paine@12	d30Si 020915 BR6 Paine@15 d30Si 020915 BR6 Paine@14	d30Si_020915_BR6_Paine@15	d30Si_020915_BR6_Paine@16	130Si_020915_Ki48_rad@l	d30Si_020915_Ki48_rad@2 d30Si_020915_Ki48_rad@3	d30Si_020915_Ki48_rad@4	430Si_020915_Ki48_rad@5	d30Si_020915_BR6_Paine@17	d30Si 020915 BR6 Paine@19	130Si_020915_BR6_Paine@20	d30Si_020915_BR6_Paine@21	d30Si_020915_BR6_Paine@22	130Si 020915 BR6 Paine@25	d30Si 020915 Ki43 rad@l	d30Si_020915_Ki43_rad@2	d30Si_020915_Ki43_rad@3	d30Si_020915_Ki43_rad@4	130Si 020915 Ki43 rad@6	130Si_020915_BR6_Paine@25	d30Si 020915 BR6 Paine@26	d30Si_020915_BR6_Paine@2/ d30Si_020915_BR6_Paine@28	430Si 020915 Ki20C_rad@1	d30Si_020915_Ki20C_rad@2	d30Si_020915_Ki20C_rad@3	d30Si_020915_Ki20C_rad@4 d30Si_020915_Ki20C_rad@5	130Si_020915_BR6_Paine@29	d30Si_020915_BR6_Paine@30	130Si 020915 BR6 Paine@32	d30Si_020915_BR6_Paine@33	d30Si 020915 BR6 Paine@34	d30Si 020915_BR6_Paine@35 d30Si 020915_BR6_Paine@36	d30Si_020915_BR6_Paine@37	d30Si_020915_BR6_Paine@38	d30Si_020915_BR6_Paine@39 d30Si_020915_BR6_Paine@40	d30Si_020915_BR6_Paine@41	d30Si_020915_BR6_Paine@42	d30Si_020915_BR6_Paine@43 d30Si_020915_BR6_Paine@44	d30Si_020915_BR6_Paine@45	d30Si_020915_BR6_Paine@46	d30Si_020915_BR6_Paine@47 d30Si_020915_BR6_Paine@48
			d30Si_02091	d30Si 02091.	d30Si_02091	d30Si_02091	d30Si 02091.	d30Si_02091.	d30Si_02091	d30Si_02091	d30Si 02091	d30Si_02091.	d30Si_02091.	d30Si_02091	d30Si_02091	d30Si_02091 d30Si_02091.	d30Si_02091	d30Si_02091	d30Si_02091	d30Si 02091.	d30Si_02091.	d30Si_02091	d30Si_02091	d30Si 02091	d30Si 02091.	d30Si_02091.	d30Si_02091	d30Si_02091	d30Si_02091	d30Si_02091	d30Si_02091	d30Si_02091 d30Si_02091.	d30Si 02091	d30Si_02091.	d30Si_02091	d30Si_02091 d30Si_02091.	d30Si_02091.	d30Si_02091	d30Si 02091.	d30Si_02091	d30Si_02091	d30Si_02091 d30Si_02091.	d30Si_02091.	d30Si_02091	d30Si_02091 d30Si_02091.	d30Si_02091	d30Si_02091	d30Si_02091 d30Si_02091,	d30Si_02091	d30Si_02091	d30Si_02091.

Table A2 Continued.

Table A2 Continued.

			SIMS ANALYSES	ALYSES		M,	Mount: BR7		Standard: UNIL-Q1 (Paine)	L-Q1 (Paine)	Anı	Analyse: δ^{30} Si			Value= -0	Value= -0.13±0.02 (NBS-28, 2σ)	BS-28, 2	5)	Date: 03.09.2015
	Beam	H'2/L'2 (30Si/28Si)	(Si/28Si)	L'2 (30Si/Coeff)	/Coeff)	H'2 (28Si/Coeff)	i/Coeff)	Time	Yield	mean	ını		mean	Drift correction	ction)	rati		Comment
	nA	CPS	2SD	CPS	2SD	CPS	2SD		CPS/nA	2SD	830 Si	2SD int	2SD	830 Si	2SD	830 Si NBS-28	8S-28 2SD	a	
d30Si_040915_Ki4c_rad@2	2.37	3.2729E-02	1.2325E-02	7.6127E+07	1.9181E-01	2.4913E+06	1.8649E-01	17:39	3.2063E+07	3.2878E+07	41.52	0.25		41.52	0.25	0.83	3 0.21	= :	Ki04C
d30Si_040915_Ki4c_rad@3	2.37	3.2667E-02	1.0837E-02	7.8304E+07	1.3228E-01	2.5580E+06	1.2756E-01	17:43	3.2974E+07	6.9141E+05	43.33	0.22	1.06	43.33	0.22	-1.06		= 5	Ki04C
430Si 040915 Ki4c rad@4	2.37	3.2681E-02 3.2701E-02	1.3559E-02	7.8335E+07	1.4863E-01	2.5601E+06	1.4785E-01 1.3648E-01	17:40	3.3005E+07		42.91	0.27		42.91	0.27	79.0	27.0 79	7 0	K104C
d30Si 040915 Ki4c rad@6	2.37	3.2694E-02	9.7254E-03	7.9001E+07	1.4777E-01	2.5827E+06	1.4588E-01	17.53	3.3264E+07		42.54	0.19		42.54	0.19	-0.24		. 9	Ki04C
d30Si 040915 Ki4c rad@7	2.38	3.2701E-02	1.0231E-02	7.7888E+07	1.5143E-01	2.5472E+06	1.5421E-01	17:56	3.2794E+07		42.34	0.20		42.33	0.20	-0.02		9.	Ki04C
d30Si_040915_Ki4c_rad@8	2.38	3.2703E-02	1.2546E-02	7.7486E+07	1.7084E-01	2.5342E+06	1.6635E-01	17:59	3.2620E+07		42.26	0.25		42.26	0.25	0.05		==	Ki04C
d30Si_040915_Ki4c_rad@9	2.37	3.2701E-02	1.2891E-02	7.7773E+07	1.4372E-01	2.5436E+06	1.3778E-01	18:03	3.2766E+07		42.32	0.26		42.32	0.26	-0.01		7.	Ki04C
d30Si 040915 Ki4c rad@10	2.38	3.2672E-02	9.7734E-03	7.8574E+07	0.0437E-01	2.5670E+06	1.4134E-01	90:81	3.3075E+07		43.18	0.20		43.17	0.20	-0.90	90 0.20	0.0	Ki04C
430Si 040015 RB7 Pains 31	2.30	3.27.22E-02	1.304/E-02	7.46905±07	1.4037E-02	2.4499E+06	0.1294E-02	18:13	3.1551E+07	3 3473 E±07	41.71		17.33	42.00		42 32 0.03	3 0 30	700	Т
d30Si 040915 BR7 Paine@22	2.38	3.2703E-02	1.5345E-02	7.9892E+07	1.3314E-01	2.6127E+06	1.3371E-01	18:16	3.3631E+07	6.0414E+05	42.28	0.31		42.27	0.31				Standard
d30Si 040915 BR7 Paine@23	2.38	3.2699E-02	1.0750E-02	7.8776E+07	1.3540E-01	2.5759E+06	1.3198E-01	18:19	3.3162E+07		42.39								
d30Si_040915_BR7_Paine@24	2.38	3.2693E-02	9.0273E-03	8.0209E+07	1.2220E-01	2.6225E+06	1.2037E-01	18:23	3.3733E+07		42.56	0.18		42.55	0.18	0	0.25 0.20	0.	Standard
d30Si_040915_Ki1R_rad@2	2.38	3.2727E-02	6.6060E-03	7.1271E+07	8.3266E-02	2.3325E+06	7.9401E-02	18:26	3.0004E+07	3.2318E+07	41.57		-42.03	41.56	0.13	0.7		6	Ki01
d30Si_040915_Ki1R_rad@3	2.38	3.2725E-02	9.5079E-03	7.6277E+07	1.4698E-01	2.4963E+06	1.4784E-01	18:29	3.2094E+07	2.1061E+06	41.64		0.90	41.63	0.19	0.71		0.	Ki01
d30Si_040915_Ki1R_rad@4	2.38	3.2716E-02	1.0750E-02	7.6057E+07	1.3781E-01	2.4881E+06	1.3567E-01	18:33	3.1998E+07		41.90	0.22			0.22	0.44		0.	Ki01
d30Si_040915_Ki1R_rad@5	2.38	3.2692E-02	1.5202E-02	7.8438E+07	1.5438E-01	2.5664E+06	1.3945E-01	18:36	3.3025E+07		42.59	0.30			0.30	-0.27		53	Ki01
d30Si_040915_Ki1R_rad@6	2.38	3.2726E-02	1.0371E-02	7.5802E+07	1.6710E-01	2.4807E+06	1.6308E-01	18:39	3.1874E+07		41.59	0.21			0.21	0.77		9.	Ki01
d30Si_040915_Ki1R_rad@7	2.38	3.2718E-02	9.4345E-03	7.8006E+07	8.1243E-02	2.5522E+06	8.3504E-02	18:43	3.2817E+07		4 : 84	0.19			0.19	0.51		9. 9	Ki01
d30Si_040915_K11K_rad@8	2.38	3.2685E-02	8.1087E-03	7.9685E+07	1.2523E-01	2.6047E+06	1.2536E-01	18:46	3.3523E+07		42.79	0.16		42.77	0.16	÷ a		5 9	Ki01
d30Si_040915_KIIK_rad@9	2.38	3.2705E-02 3.2696E-02	9.21/3E-03 1.5368E-02	7.8550E+07	1.4268E-01	2.5625E+06 2.5000E+06	1.4096E-01	18:49	3.2982E+0/ 3.3326E+07		42.21	0.18		42.19	0.18	0.12	0.20	2 5	K101
d30Si 040915 Ki32 rad@1	2 38	3.2746F-02	9 9746F-03	7 6427E+07	1 5956F-01	2 5029E+06	1 5584F-01	18.56	3 2177E+07		41.03	0.20		41.00	0.00	- 13			Ki32
d30Si 040915 BR7 Paine@25	2.37	3.2705E-02	1.0661E-02	8.0291E+07	1.4897E-01	2.6256E+06	1.4693E-01	18:59	3.3811E+07	3.3515E+07	42.22	0.21	-42.34	42.19	0.21	42.32 0.12	2 0.20	00'0	Standard
d30Si 040915 BR7 Paine@26	2.38	3.2698E-02	1.1091E-02	7.8955E+07	1.4315E-01	2.5815E+06	1.4135E-01	19:03	3.3211E+07	5.7907E+05	-42.42	0.22	0.21	42.39	0.22 (0.18 -0.08	0.21	0.19	
d30Si_040915_BR7_Paine@27	2.38	3.2697E-02	1.2416E-02	8.0114E+07	1.3865E-01	2.6211E+06	1.2694E-01	19:06	3.3707E+07		42.44	0.25		42.41	0.25	-0.11		==	Standard
d30Si_040915_BR7_Paine@28	2.38	3.2702E-02	1.3578E-02	7.9193E+07	1.4346E-01	2.5915E+06	1.3255E-01	19:09	3.3331E+07		42.30			42.27	0.27	0.04	4 0.22	.2	Standard
d30Si_040915_Ki32_rad@2	2.38	3.2763E-02	1.4155E-02	7.2852E+07	8.8968E-02	2.3856E+06	8.0526E-02	19:13	3.0657E+07	3.0895E+07	40.50			40.47	0.28	1.92		13	Ki32
d30Si_040915_Ki32_rad@3	2.38	3.2758E-02	8.1320E-03	7.4174E+07	1.8626E-01	2.4297E+06	1.8332E-01	91:16	3.1221E+07	1.9450E+06	40.67		0.75	40.64	0.16	1.74		6	Ki32
d30Si_040915_Ki32_rad@4	2.38	3.2767E-02	1.2007E-02	7.4106E+07	1.9446E-01	2.4280E+06	1.9182E-01	9:16	3.1175E+07		40.41	0.24		40.38	0.24	2.02	0.21	= 9	Ki32
d30Si 040915 Ki32 rad@6	2.38	3.2760E-02 3.2772E-02	9.4522E-05 1.6343E-07	7.1276F+07	2 0414F-01	2.3420E+06	1.8/08E-01	19.26	3.00/2E+0/ 2.9999E+07		40.00	0.19		40.57	0.19	2 19		2 7	Ki32
d30Si 040915 Ki32 rad@7	2.38	3.2774E-02	1.1828E-02	6.9365E+07	2.1179E-01	2.2734E+06	2.0952E-01	19:29	2.9184E+07		40.19	0.24		40.15	0.24	2.25		: =:	Ki32
d30Si_040915_Ki32_rad@8	2.38	3.2793E-02	1.1851E-02	7.2993E+07	2.2250E-01	2.3937E+06	2.2439E-01	19:33	3.0718E+07		-39.63	0.24		-39.59	0.24	2.84		=	Ki32
d30Si_040915_Ki32_rad@9	2.38	3.2757E-02	1.1189E-02	7.4943E+07	1.0623E-01	2.4551E+06	1.0541E-01	19:36	3.1515E+07		40.69	0.22		40.65	0.22	1.73			Ki32
d30Si_040915_Ki32_rad@10	2.38	3.2761E-02	1.0789E-02	7.6603E+07	1.6177E-01	2.5097E+06	1.5683E-01	19:39	3.2237E+07		40.58	0.22		40.53	0.22	_	.86 0.21		Ki32
d30Si_040915_BR7_Paine@29	2.38	3.2699E-02	1.0052E-02	7.8953E+07	1.2690E-01	2.5832E+06	1.1595E-01	19:46	3.3243E+07	3.3342E+07	42.39	0.20	42.44	42.34	0.20	42.39 -0.03	03 0.20	00.09	
430Si 040915_BR/_Faine@30	2.38	3.2/05E-02 3.2602E-02	1.066/E-02	8.0284E+07	1.3430E-01	2.62./0E+06 2.606/E+06	1.2416E-01	19:49	3.35//3E+0/ 3.3500E+07	7.9018E+03	42.21			42.10					
d30Si 040915 BR7 Paine@32	2.38	3.2693E-02	1.4567E-02	7.8079E+07	1.4935E-01	2.5544E+06	1.3539E-01	19:56	3.2842E+07		42.58	0.29		42.53	0.29	Ģ		: ::	Standard
d30Si_040915_Ki34S_rad@1	2.38	3.2718E-02	1.4395E-02	7.2962E+07	3.7414E-01	2.3870E+06	3.7193E-01	20:29	3.0681E+07		41.82	0.29		41.76	0.29	0.5	8 0.2	3	Ki34
d30Si_040915_BR7_Paine@33	2.38	3.2699E-02	1.1880E-02	7.9544E+07	1.5090E-01	2.6009E+06	1.4877E-01	20:33	3.3431E+07	3.3038E+07	42.38		_	42.32				90.0- 13	5 Standard
d30Si_040915_BR7_Paine@34	2.38	3.2697E-02	1.1580E-02	7.7549E+07	1.5769E-01	2.5358E+06	1.5553E-01	20:36	3.2582E+07	1.7158E+06	42.45		0.07	42.39		0.06 -0.08			_
d30Si_040915_BR7_Paine@35 d30Si_040915_BR7_Paine@36	2.38	3.2697E-02 3.2698E-02	1.0881E-02	8.0952E+07	1.1373E-01	2.6487E+06 2.4985E+06	1.0839E-01	20:39	3.4029E+07 3.2109E+07		42.45	0.22		42.39	0.22	80.0	0.08 0.21	2.2	Standard
d30Si 040915 Ki34S rad@2	2.38	3.2740E-02	1.0332E-02	7.8865E+07	1.3088E-01	2.5821E+06	1.3295E-01	20:46	3.3192E+07	3.3004E+07	41.18		-41.40	41.12	0.21	1.25		. 0.	Ki34
d30Si_040915_Ki34S_rad@3	2.38	3.2742E-02	1.2278E-02	7.9581E+07	1.4501E-01	2.6054E+06	1.4147E-01	20:49	3.3440E+07	1.8242E+06	41.13	0.25	0.53	41.06	0.25	1.30	0.21	==	Ki34
d30Si_040915_Ki34S_rad@4	2.38	3.2727E-02	1.3991E-02	7.7557E+07	1.5705E-01	2.5402E+06	1.4536E-01	20:53	3.2598E+07		41.56	0.28		41.49	0.28	0.85		7	Ki34
d30Si_040915_Ki34S_rad@5	2.38	3.2738E-02	1.1103E-02	7.9996E+07	1.3153E-01	2.6190E+06	1.2928E-01	20:56	3.3603E+07		41.25	0.22		41.18	0.22	1.18		= 5	Ki34
430Si_040915_K154S_rad@6	2.38	3.2/32E-02	1.5/80E-02	7.816/E+0/	1.66/4E-01	2.558/E+06	1.6541E-01	20:59	3.2824E+0/		4 5	0.28		41.57	0.28	06.0	77.0	7 =	Ki34
d30Si 040915 Ki34S rad@8	2.30	3.27.38E-02	1.1324E-02	7.8033E+07	1.7029E-01	2.5577E+06	1.8328E-01	21.05	3.3014E+07		1 7	0.23		1 1 1	0.23	1.16			N.54
d30Si_040915_Ki34S_rad@9	2.38	3.2719E-02	1.2330E-02	8.0386E+07	1.5851E-01	2.6299E+06	1.5703E-01	21:09	3.3815E+07		18.14	0.25		41.73	0.25	09:0		: =:	Ki34
d30Si_040915_Ki34S_rad@10	2.38	3.2731E-02	1.4680E-02	7.9626E+07	1.6714E-01	2.6061E+06	1.6125E-01	21:13	3.3488E+07		41.44			41.36			9 0.2	3	
d30Si_040915_BR7_Paine@37	2.37	3.2695E-02	1.4404E-02	7.5378E+07	2.1280E-01	2.4668E+06	1.9983E-01	21:16	3.1741E+07	3.4492E+07	42.51			42.43		_			
430Si 040915_BR/_Paine@38	2.38	3.2695E-02	9.7545E-03	8.2600E+0/	1.0524E-01	2.7006E+06	9.9/84E-02	21:19	3.4/48E+0/	4.5//1E+06	42.50	0.20	0.50	42.42		0.45 -0.12		0.45	
d30Si_040915_BR7_Paine@40	2.38	3.2678E-02	1.0592E-02	8.8088E+07	1.4745E-01	2.8764E+06	1.6072E-01	21:26	3.7085E+07		43.00	0.21		42.92	0.21	-0.63	63 0.20	.0	Standard

Table A2 Continued.

Setting: Standard Setting: Standard Setting: Standard Setting: Standard Setting: Standard
N NISSA
252 8
-41.96 0.16
6¹⁰ S1 2SD int 42. 03 0.22 41. 97 0.27 441. 97 0.27 441. 91 0.33 441. 94 0.41 441. 82 0.31 45. 04 0.21
7112E+07 3.7091E+07 7203E+07 1.3945E+05 7140E+07 1.3945E+05 895E+07 7067E+07 7110E+07 7110E+07
3.7112E+07 3.7203E+07 3.7140E+07 3.6965E+07 3.7068E+07 3.7110E+07 3.7110E+07 3.7110E+07
5-01 9:33 5-02 9:37 5-02 9:40 5-02 9:43 5-01 9:46 5-01 9:50 5-02 9:53
0.00 1.0921E-01 0.00 9.2405E-02 0.00 9.1645E-02 0.00 9.3164E-02 0.00 1.0047E-01 0.00 9.6693E-02 0.00 9.6693E-02
2.9214E+06 2.9392E+06 2.9358E+06 2.9218E+06 2.9263E+06 2.9346E+06 2.9411E+06 2.9380E+06
1.0787E-01 9.2660E-02 8.8443E-02 8.2644E-02 9.7514E-02 9.6322E-02 9.0500E-02 9.1614E-02
8,9319E+07 8,9839E+07 8,973E+07 8,946E+07 8,9677E+07 8,991E+07 8,991E+07
1.0759E-02 1.0975E-02 1.3642E-02 1.6678E-02 2.0306E-02 2.0341E-02 1.5530E-02
3.2711E-02 3.2713E-02 3.2713E-02 3.2713E-02 3.2713E-02 3.2713E-02 3.2709E-02
2. 2. 2. 2. 2. 4. 4. 4. 4. 4. 4. 4. 4. 4. 4. 4. 4. 4.
d30Si_030316_Paine@1 d30Si_030316_Paine@2 d30Si_030316_Paine@3 d30Si_030316_Paine@3 d30Si_030316_Paine@3 d30Si_030316_Paine@3 d30Si_030316_Paine@3

Table A2 Continued.

			SIMS AN	SIMS ANALYSES		M	Mount: BR5		Standard: UNIL-Q1 (Paine)	QI (Paine)	Ans	Analyse: 8 ³⁰ Si			Value= -0	Value= -0.13±0.02 (NBS-28, 2σ)	NBS-28,	2σ)		Date: 03.09.2015
	Beam	H'2/L'2	H'2/L'2 (30Si/28Si)	L'2 (30Si/Coeff)	i/Coeff)	H'2 (28Si/Coeff)	/Coeff)	i	Yield	mean	Measurements		mean	Drift correction	ction		Calibration	_		
	nA	CPS	2SD	CPS	2SD	CPS	2SD	Time	CPS/nA	2SD	830 Si	11	2SD	δ ³⁰ Si	2SD	630 SI NBS-23	VBS-28 2.	as		Comment
d30Si_030316_PaineBR5@1	2.39	3.2730E-02	1.2599E-02	8.9573E+07	1.0093E-01	2.9319E+06	1.0717E-01	16:17	3.7465E+07	3.7413E+07	41.50		_		0.25	41.85 0.	0.18 0	0.23 -0	-0.18 Sett	Setting: Standard
430Si_030316_PaineBKS(@02	2.39	3.2/21E-02	1.0458E-02	8.9823E+0/	1.0913E-01	2.9390E+06	1.0/32E-01	1621	3.7539E+07	2.3644E+05	6.2	0.21	0.40	9.14						Setting: Standard
d30Si 030316 PaineBR5@04	2.39	3.2711E-02	2.1218E-02	8.9126E+07	9.7604E-02	2.9159E+06	9.8091E-02	16.27	3.7230E+07		42.03	0.42			0.42	9		0.29	S. Se	Setting: Standard
d30Si_030316_PaineBR5@05	2.39	3.2716E-02	2.1827E-02	8.9233E+07	1.1680E-01	2.9191E+06	1.1611E-01	16:30	3.7355E+07		41.90	0.44		41.91	0.44	9	-0.24 0	0.29	Set	Setting: Standard
d30Si_030316_PaineBR5@06	2.40	3.2712E-02	1.3882E-02	8.9614E+07	9.7443E-02	2.9324E+06	1.0325E-01	16:34	3.7386E+07		42.02	0.28			0.28	9		0.24	Set	Setting: Standard
d30Si_030316_PaineBR5@07	2.40	3.2715E-02	1.4699E-02 9.9247E-03	8.9665E+07 8.9736E+07	9.7678E-02	2.9335E+06 2.9354E+06	9.8519E-02	16:37	3.7371E+07 3.7355E+07		41.92	0.29		41.93	0.29	99	0.26	0.24	Set	Setting: Standard
430Si 030316 PaineBR 5@09	2.40	3 2722E-02	1.1383E-02	8 9731E+07	9 3143E-02	2.9353E+06	9 5543E-02	17:32	3 7343E+07	3 7437F+07	41.72		41 70	41.73					Т	Standard
d30Si 030316 PaineBR5@10	2.40	3.2707E-02	1.6588E-02	9.0586E+07		2.9632E+06	1.0919E-01	17:35	3.7812E+07	5.0357E+05	42.15	0.33			0.33	0.42 -0.		0.25 0	0.44 Sta	Standard
d30Si_030316_PaineBR5@11	2.39	3.2726E-02	1.1308E-02	8.9312E+07	8.5992E-02	2.9228E+06	8.8626E-02	17:39	3.7316E+07		41.60	0.23						.22	Sta	Standard
d30Si_030316_PaineBR5@12	2.39	3.2723E-02	1.1822E-02	8.8908E+07	9.9542E-02	2.9094E+06	1.0273E-01	17:42	3.7276E+07		41.68			41.69	0.24	9	0.01 0	0.23	Sta	tandard
d30Si_030316_KI38@1	2.38	3.2767E-02	9.6572E-03	8.7401E+07	1.1483E-01	2.8638E+06	1.1743E-01	17:45	3.6678E+07	3.6738E+07	40.40				0.19			0.22	Ki3	
d30Si_030316_KI38@2	2.39	3.2745E-02	1.6468E-02	8.8321E+07	1.0313E-01	2.8895E+06	1.1617E-01	17:48	3.7001E+07	4.6645E+05	4.04		69.0		0.33	0		52 2	Ki38	
d30Si_030316_KI38@3	2.39	3.2749E-02	1.6855E-02	8.7888E+07	1.2609E-01	2.8783E+06	1.2716E-01	17:52	3.6789E+07		40.92	0.34			0.34	0 -		97.5	Ki38	00 (
d30Si_030316_K138@4	2.39	3.2743E-02	1.4869E-02	8.6/69E+0/	9.45/2E-02	2.8429E+06	9.8309E-02	65:/1	3.6235E+07		40.65	0.30		40.04	0.30		0 87 0	0.24	Ki38	
430Si 030316 K138@6	2.40	3.27425-02	1.3239E-02	6.7690E±07	9.3336E-02	2.6762E±06	1.0336E-01	10:01	3.6855E±07		71.17	0.51			0.31			0.20	N138	
d30Si 030316 K138@7	2.39	3.2746E-02	1.2357E-02	8 7202E+07	1.2500E-01	2.8567E+06	1.1298E-01	18:05	3.6523E+07		4 102	0.25			0.25	0		0.23	N130	
d30Si 030316 KB8@8	2.39	3.2738E-02	1.0977E-02	8.8044E+07	1.1828E-01	2.8824E+06	1.2185E-01	18:08	3.6892E+07		41.26	0.22			0.22	0		0.22	Ki38	
d30Si_030316_KB8@9	2.39	3.2723E-02	1.8451E-02	8.8567E+07	1.0884E-01	2.8986E+06	1.1093E-01	18:11	3.7007E+07		41.68	0.37			0.37	9		0.27	Ki38	- 00
d30Si_030316_KI38@10	2.40	3.2742E-02	1.8200E-02	8.8034E+07	1.0554E-01	2.8807E+06	1.1634E-01	18:14	3.6744E+07		41.13	0.36		41.13	0.36		0.57 0	0.27	Ki3	8
d30Si_030316_PaineBR5@13	2.39	3.2723E-02	2.5206E-02	8.9681E+07	8.3345E-02	2.9349E+06	8.0731E-02	18:18	3.7470E+07	3.7493E+07	41.69									Standard
d30Si_030316_PaineBR5@14	2.39	3.2709E-02	9.5730E-03	8.9554E+07	9.9818E-02	2.9297E+06	1.0143E-01	18:21	3.7506E+07	1.4107E+05	42.09		0.35			0.30 -0.		0.22 0	0.32 Star	Standard
430Si 030316 PaineBK3@15	2.39	3.2712E-02	1.6328E-02	8.9/2/E+0/ 0.0624E+07	0.3673E-01	2.9355E+06	1.0840E-01	18:24	3.7382E+0/ 3.7414E±07		42.01	0.33		42.01	0.33	۰ ۰	0 22 0	0.23	Sta	Standard
d30Si 030310 rameBR5@10	2.40	3.2714E-02	2.0163E-02	8 9743E+07	0 5	2 9369E+06	8.7169F-02	19:10	3.7581E+07	3 7565F+07	41.6/		-41 68			41 68 -0			-0 01 Sta	Standard
d30Si 030316 PaineBR5@18	2.39	3.2733E-02	1.3335E-02	8.9291E+07		2.9227E+06	9.7886E-02	19:13	3.7429E+07	2.1225E+05	41.39							0.24 0		Standard
d30Si 030316 PaineBR5@19	2.38	3.2721E-02	9.5349E-03	8.9482E+07	1.0740E-01	2.9281E+06	1.1118E-01	19:16	3.7562E+07		41.74									Standard
d30Si 030316 PaineBR5@20	2.39	3.2725E-02	1.0092E-02	8.9967E+07	9.9850E-02	2.9442E+06	1.0295E-01	19:19	3.7688E+07		4.64	0.20		41.64	0.20	0	0.04 0	0.22	Sta	Standard
d30Si 030316 PaineBR5@21	2.38	3.2713E-02	8.0536E-03	8.9526E+07	1.0469E-01	2.9286E+06	1.0780E-01	20:12	3.7688E+07	3.7556E+07	41.99	0.16	41.74		0.16	41.74 -0.	-0.33 0		-0.06 Sta	Standard
d30Si_030316_PaineBR5@22	2.38	3.2719E-02	1.0759E-02	8.9650E+07	1.0102E-01	2.9334E+06	1.0200E-01	20:15	3.7641E+07	2.6451E+05	41.80					0.49 -0.				Standard
d30Si_030316_PaineBR5@23	2.39	3.2735E-02	1.8993E-02	8.9235E+07	8.2768E-02	2.9202E+06	8.7244E-02	20:18	3.7402E+07		41.34	0.38			0.38	0	0.35 0	0.27	Sta	Standard
d30Si_030316_PaineBR5@24	2.38	3.2719E-02	1.8026E-02	8.9227E+07	8.9843E-02	2.9197E+06	9.5974E-02	20:21	3.7493E+07		-41.82									tandard
d30Si_030316_PaineBRS@25	2.37	3.2725E-02	9.4497E-03	8.9020E+07	9.3873E-02	2.9132E+06	9.4630E-02	20:57	3.7497E+07	3.7523E+07	41.62	- 61.0		41.62	0.19	41.68 0.		0.22 0	0.00 Star	Standard
430Si 030316 PaineBKS@26	2.3/	3.2714E-02	9.4/38E-03	8.9036E+0/	1.2596E-01 0.4406E-02	2.9128E+06	0.7635E-01	21:00	3.7552E+0/ 3.7547E+07	6.1096E+04	4.14		0.40				0 97.0			Standard
d30Si 030316 PaineBR5@28	2.38	3.2731E-02	2.3450E-02	8.9223E+07	8.0472E-02	2.9228E+06	8.5623E-02	21:07	3.7496E+07		41.47	0.47			0.47	0		0.30	Sta	Standard
d30Si_030316_PaineBR5@29	2.38	3.2722E-02	1.7666E-02	8.9386E+07	1.0125E-01	2.9250E+06	1.0752E-01	21:59	3.7602E+07	3.7442E+07	41.71								-0.06 Star	Standard
d30Si_030316_PaineBR5@30	2.39	3.2717E-02	1.7077E-02	8.9014E+07	7.6190E-02	2.9124E+06	7.6389E-02	22:02	3.7318E+07	2.3680E+05	41.86									Standard
d30Si_030316_PaineBR5@31	2.38	3.2720E-02	2.1973E-02	8.9071E+07	8.3952E-02	2.9145E+06	8.9301E-02	22:05	3.7436E+07		41.77	0.44		5.176	0.44	9 3		0.29	Sta	Standard
430Si 030316 PaineBRS(#32	2.37	3.2726E-02	1.25305E-02	8.883/E+0/		2.90/8E+06	8.6051E-02	55:06	3.7411E+0/	2 74520 .07	41.39		41 04						1	Standard
d30Si 030316 PaineBR5@34	2.39	3.2725E-02	9.0185E-03	8.9135E+07	8.3633E-02	2.9171E+06	8.6517E-02	23:04	3.7365E+07	2.1759E+05	41.63	0.18	0.40	41.63	0.18	0.34	0.05	0.21 0	0.36 Sta	Standard
d30Si_030316_PaineBR5@35	2.38	3.2709E-02	1.0680E-02	8.9046E+07	7.4305E-02	2.9131E+06	7.8298E-02	23:07	3.7359E+07		42.10									Standard
d30Si_030316_PaineBR5@36	2.38	3.2717E-02	1.4468E-02	8.9289E+07	1.1296E-01	2.9197E+06	1.2456E-01	23:11	3.7581E+07		41.87				0.29	0-		0.24	Sta	tandard
d30Si_030316_KI6CS@1	2.38	3.2722E-02	1.9406E-02	8.7653E+07	1.1806E-01	2.8679E+06	1.1871E-01	23:14	3.6853E+07	3.6480E+07	17.14	0.39			0.39	9 3		0.27	Kio	Ki06cs
430Si 030316 KI6CS@02	2.38	3.2724E-02 3.2729E-02	1.5755E-02 1.1059E-02	8.7634E+07	1.2918E-01	2.8560E+06	1.319/E-01 1.0664E-01	23:20	3.6609E+07	3.7030E+03	6 4 5		0.08	41.00	0.32	0	0 70.0	0.23	N S	K106cs
d30Si 030316 KI6CS@04	2.38	3.2717E-02	1.0195E-02	8.6466E+07	1.1364E-01	2.8289E+06	1.1619E-01	23:24	3.6270E+07		41.86	0.20			0.20	9		0.22	Kin	Ki06es
d30Si_030316_KI6CS@05	2.38	3.2727E-02	1.2670E-02	8.6605E+07	1.2435E-01	2.8346E+06	1.2345E-01	23:27	3.6401E+07		41.57	0.25			0.25	0		0.23	Kio	G06cs
d30Si_030316_KI6CS@06	2.38	3.2731E-02	1.2047E-02	8.6069E+07	1.3062E-01	2.8174E+06	1.3209E-01	23:30	3.6140E+07		41.45	0.24			0.24	0		0.23	Ki0	ii06cs
d30Si_030316_KI6CS@07	2.39	3.2715E-02	2.0194E-02	8.6460E+07	7.6094E-02	2.8291E+06	8.9311E-02	23:33	3.6238E+07		41.91	0.40			0.40	9 3	0.24 0	0.28	Kio	Gi06cs
430Si 030316 KI6CS@09	2.38	3.27.30E-02 3.2716E-02	2.363/E-02 2.1692E-02	8.71/2E+0/ 8.6667E+07	1.061/E-01	2.8359E+06	1.1525E-01 1.2215E-01	23:40	3.6259E+0/		4.14	0.47		4 14	0.47	> 9		0.29	Z Z	Ki06cs
d30Si 030316 KI6CS@10	2.38	3.2728E-02	1.8277E-02	8.6594E+07	1.0120E-01	2.8339E+06	1.0515E-01	23:43	3.6394E+07		41.54	0.37			0.37	0		0.27	K.	Ki06cs
d30Si_030316_KI6CS@11	2.38	3.2702E-02	9.8627E-03	8.7268E+07	1.0338E-01	2.8539E+06	1.0495E-01	23:46	3.6597E+07		42.30	0.20		42.29	0.20	9		0.22	Ki0	Ki06cs
d30Si_030316_KI6CS@12	2.39	3.2689E-02	9.9951E-03	8.7275E+07	7.8217E-02	2.8530E+06	7.9221E-02	23:50	3.6579E+07		42.69	0.20			0.20	Ţ.		.22	Ki0	Ki06cs
d30Si_030316_Kl6CS@13 d30Si_030316_Kl6CS@14	2.38	3.2721E-02 3.2727E-02	1.1297E-02 1.4451E-02	8.6792E+07 8.6860E+07	1.3359E-01	2.8398E+06	1.3558E-01	23:53	3.6487E+07		41.76	0.23		41.75	0.23	79	80.0	0.22	Kio	Ki06cs
d30Si 030316 PaineBR5@37	2.39	3.2729E-02	1.7262E-02	8.9669E+07	9.5199E-02	2.9330E+06	1.0826E-01	23:59	3.7575E+07	3.7601E+07	41.50		-41.76			41.75 0.			-0.08 Star	Standard
d30Si_030316_PaineBR5@38	2.40	3.2716E-02	9.9543E-03	9.0157E+07		2.9500E+06	1.1168E-01	0:03	3.7643E+07	2.6371E+05	41.90									Standard
d30Si_030316_PaineBR5@39	2.40	3.2720E-02	1.3629E-02	9.0501E+07	9.3523E-02 9.4685E-02	2.9616E+06	9.3058E-02 9.5947E-02	90:0	3.7750E+07		41.79	0.27		41.78	0.27	99	0.11 0	0.24	Sta	Standard
d30Si 030316 PaineBR5@41	2.40	3.2719E-02	1.2431E-02	8.9440E+07	1.0284E-01	2.9266E+06	1.0764E-01	1:01	3.7325E+07	3.7387E+07	41.80		41.88			41.87 -0			-0.20 Sta	Standard
d30Si_030316_PaineBR5@42	2.39	3.2715E-02	1.7413E-02	8.9710E+07		2.9354E+06	9.4042E-02	1:04	3.7473E+07	2.6215E+05	41.93		0.30							Standard
d30Si_030316_PaineBR5@43 d30Si_030316_PaineBR5@44	2.39	3.2710E-02 3.2722E-02	1.7304E-02 2.1597E-02	8.9676E+07 8.9067E+07	8.7877E-02 9.5382E-02	2.9342E+06 2.9147E+06	9.4081E-02	80:1	3.7517E+07 3.7234E+07		42.07	0.35		42.06	0.35	79	0.40	0.26	Sta	Standard
double boosty rameday water	4.37	3.47.444.446	4,102/104	0.700/15:10/	0	Z.714/12/00	LV2000EVI	1711	3.72340107		41.10	0.40			0.40	r		67	0.00	dard

二次イオン質量分析法 (SIMS) を用いた 中部日本犬山地域中生代層状チャート中の放散虫殻 Si 同位体分析

Maximilien BÔLE・池田 昌之・Peter O. BAUMGARTNER・ 堀 利栄・Anne-Sophie BOUVIER

要 旨

全球シリカ循環は長期的気候システムの重要な要素だが、その制御要因は古環境指標の制約に乏しいため、不確実性が大きい。本論では、二次イオン質量分析計 (SIMS) によって測定された犬山地域の中生代チャートに含まれる放散虫化石のシリカ変動 (δ^{30} Si) を報告する。測定の結果、放散虫殻 δ^{30} Si は -0.3 ~ 2 %で、現在及び新生代の放散虫殻の値と調和的であった。さらに、予察的な δ^{30} Si 変動は低解像度にもかかわらず、1,000 万年スケールでは生物起源シリカ (BSi) 埋没速度と逆相関し、従来の古生産性プロキシとしての δ^{30} Si の解釈に矛盾する結果となった。この時間スケールではBSi 埋没速度は風化速度に依存するため、風化しやすく低 δ^{30} Si の苦鉄質岩の風化速度変化によって、この逆相関は説明されるかもしれない。さらに高解像度で δ^{30} Si 記録を測定することで、過去のシリカ循環をより深く理解できると期待される.